R&S®ESSENTIALS

MXO 3 Series OSCILLOSCOPE

Next generationoscilloscope: Fast. Precise.Compact.



Product Brochure Version 05.00

More at: www.rohde-schwarz.com/product/mxo3

ROHDE&SCHWARZ

Make ideas real







MXO 3 SERIES OSCILLOSCOPE

FAST, PRECISE, COMPACT,

Get big capabilities in a small package. Gain the freedom and versatility your work demands without compromising on results. Enjoy unmatched performance to quickly and easily gain expert understanding of your device under test.



4-channel model

8-channel model

Bandwidth: 100 MHz to 1 GHz

Fast:

4.5 million acquisitions/s, up to 99 % real time capture

Precise:

12-bit ADC, 18-bit HD mode, digital trigger

Compact:

11.6" Full HD display and feature-packed

WHY ENGINEERS LOVE ROHDE & SCHWARZ OSCILLOSCOPES

- Atrusted,global high-quality companywithalong-standing commitment to customers and continuous technological innovation The newest oscilloscope portfolio from 60 MHz to
- ▶ 16 GHz In-house ASICs for the world's most responsive
- ► oscilloscopes Frontend technology development for pristine
- ▶ signal integrity 18-bit architecture with HD mode for the highest
- ► resolution Digital triggers for the world's most sensitive event
- ▶ isolation Superior user interface and front panel to streamline
- ▶ workflows

WHY THE MXO 3 SERIES

 Gain thefreedom and versatilityyourwork demands without compromising on results. Equipped with next-generation MXO technology, the MXO 3 series delivers fast and precise measurements in a small package

► Fast

- Industry's fastest update rate of up to
 - 4.5 million acquisitions/s
- The highest real-time signal capture up to 99 %
- Fast in both the time and frequency domains

▶ Precise

- 12-bit ADC at all sample rates, 18-bit in HD mode
- Advanced and flexible digital trigger
- Deep 125 Mpoints standard memory

▶ Compact

- Save space with all models that fit comfortably on your bench
- See and share easily with the large 11.6" Full HD display
- Rackmount with 5U height for all models

CONTENTS

FEATURES AND BENEFITS

PAGE 4

OPTIONS

PAGE 16

KEY APPLICATIONS

PAGE 23

PROBES AND ACCESSORIES

PAGE 25

SPECIFICATIONS OF BASE UNIT

PAGE 29

ORDERING INFORMATION

PAGE 39

OSCILLOSCOPE PORTFOLIO

PAGE 42

- ▶4- and 8-channel models
- ▶ 100 MHz to 1 GHz bandwidth
- ▶5 Gsample/s sample rate
- ▶ 125 Mpoints per channel standard memory
- ▶ 12-bit ADC at all sample rates

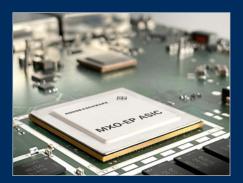




MXO 3 OSCILLOSCOPE TECHNOLOGY

FAST. PRECISE. COMPACT.

MXO 3 series oscilloscopes blend cutting-edge hardware and software technology for fast and precise results in a compact format.



Fast.

AllMXO oscilloscopes incorporate cutting-edge ASIC technology. Get the world's fastest update rate of up to 4.5 million acquisitions/s enabled by the Rohde & Schwarz MXO-EP ASIC that processes 400 Gbit/s. This chip also enables hardware-accelerated functions including math, spectrum, zone triggering and mask testing.



Precise.

The low-noise frontend Rohde & Schwarz ASIC technology, 12-bit vertical resolution in Rohde & Schwarz proprietary ADC technology and 18-bit resolution and digital trigger that is so sensitive it can trigger on smallest signal details combine to make the most precise oscilloscope in its class. The 125 Mpoints standard memory and up to 500 Mpoints option can capture hundreds of milli- seconds of time while retaining a fast sample rate and full bandwidth.



Compact.

The innovative technology in both the 4-channel and 8-channel models comes in a surprisingly small package even though MXO 3 oscilloscopes still have a large 11.6" Full HD display. The small footprint and light weight mean the oscilloscope is easy to place on a crowded bench or quickly move to a new measurement location. For rackmounting, it is just 5U high.





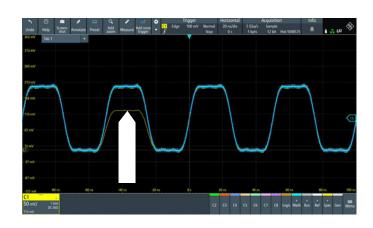
FAST

SEEMORE SIGNAL DETAILS AND SUBTLE CHANGES INSTANTLY.

- ▶ Upto99 % real-time capture
- ► Hardware-accelerated functionality
- ► Industry's fastest spectrum

Up to 99 % real-time capture

While most oscilloscopes capture less than 2 % of realtime system activity, MXO oscilloscopes capture up to 99 % of your signal's activity. Instantly see details that other oscilloscopes miss. With 4.5 million waveforms/s, quickly see rare events and anomalies that other oscilloscopes mask. Minimum trigger re-arm time is just 21 ns versus microseconds on other oscilloscopes.



Hardware-accelerated everything

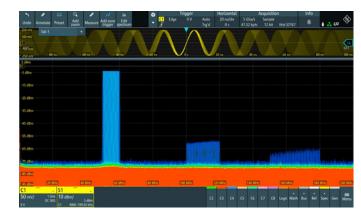
What other companies do with software, MXO oscilloscopes do with hardware. The MXO 3 incorporates hardware accelerated:

- ► Math (up to 700 000 operations/s)
- ► FFTs (up to 50 000 FFTs/s)
- ► HD filters (up to 4.5 million acquisitions/s)
- ➤ Zone triggering (up to 600 000 triggers/s)
- ► Mask testing (up to 4 000 000 tests/s)
- > XY mode (up to 2 000 000 plots/s)
- ► Protocol decode



Industry's fastest spectrum

MXO 3processes FFTs in hardware to created it spectrum display. See details in the frequency domain, including dynamic signal changes that other oscilloscopes cannot show. The free-run trigger mode is only found on Rohde & Schwarz oscilloscopes and ensures the fastest spectrum performance available of 50 000 FFTs/s.







PRECISE

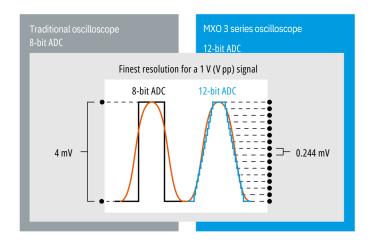
NOTHINGGETSPAST YOU.

- ► Lownoiseplus more vertical resolution
- ► Sharper view of signals in HD mode
- ▶ Biggest offset in the industry for higher SNR

Low noise plus more vertical resolution

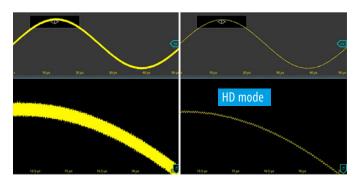
Seesmall signalchanges in the presence of larger signals:

- ► With 12-bit vertical resolution in hardware at all sample rates, 16x more resolution than 8-bit oscilloscopes
- Low-noise: only < 50 μV RMS noise on 1 M Ω and 50 Ω paths at 1 mV/div with 100 MHz bandwidth



Sharper view of signals in HD mode

Use HD mode to see signaldetail that would normally be buried in noise. HD mode offers both noise reduction and up to 18 bit vertical resolution. Unlike other oscilloscopes, HD mode runs at full sample rate and is done in hardware so it's both precise and fast.



Biggest offset in the industry for higher SNR

The most sensitivevertical scale reveals more of a signal and less measurement system noise. MXO 3 oscilloscopes have large ± 3 V offset at 1 mV/div on both 50 Ω and 1 M Ω paths. Zoom in on small-amplitude signals to get best SNR. The offset is 2x to 3x better than other leading models in the industry.







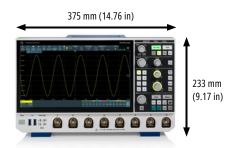
COMPACT

GETBIGCAPABILITIES IN A SURPRISINGLY SMALL PACKAGE.

- ► Fits anywhere
- ► Lots of capabilities in a small size
- ▶ Still has vibrant large 11.6" Full HD display

Fits anywhere

Small MXO 3 oscilloscope footprint and light weight make them easy to fit anywhere - even on crowded benches. The small footprint leaves more space for the creative mess of engineering. The instrument only uses 5U on a rack.

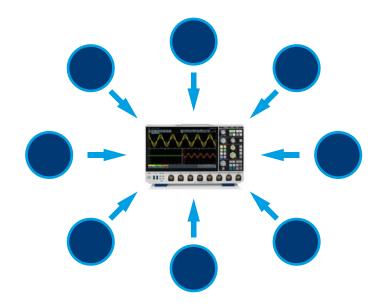




Lots of capabilities in a small size

Useyour MXO 3 oscilloscope for a wide variety of challenges with n-in-1 instrument integration:

- Spectrum analyzer
- Logic analyzer (MSO)
- ► Protocol analyzer (serial buses)
- **►** DMM
- ► Function generator
- ► FRA (Bode plot frequency response analyzer)



Still has vibrant large 11.6" Full HD display

Though small, the MXO 3 still has a 11.6" Full HD display and a front panel harmonized with other MXO oscilloscopes to make it easy to use and share measurement insight with others.





DEEP ACQUISITION MEMORY

OSCILLOSCOPESTAYSRESPONSIVE, EVENWITHDEEP MEMORY.

Deepmemory when you need it

- Accurately capture long time without the headaches
- Independent sample rate, record length and timebase settings

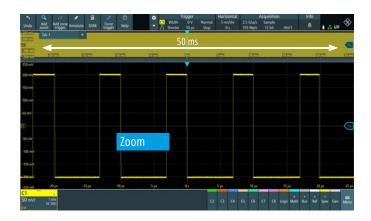
Deep memory when you need it

MXO 3comes standard with 125 Mpoints of memory per channel and an option to upgrade to 500 Mpoints. At any sample rate, deeper memory lets your oscilloscope acquire more time. You may not know how much time you need to capture for a particular challenge and having deep memory is a great insurance policy.



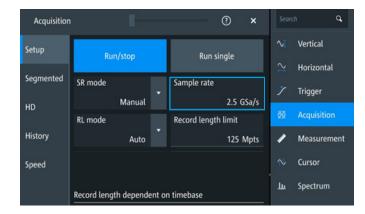
Accurately capture long time without the headaches

Capturing millisecondsor longeronmost oscilloscopes often results in an inaccurate capture. When an oscilloscope runs out of memory, it compensates by reducing sample rate often aliasing captured signals. The MXO 3 memory of 125 Mpoints captures 50 ms of time at full 1 GHz bandwidth with 2.5 Gsample/s without any worry. Or 200 ms of time with 500 Mpoints at 2.5 Gsample/s.



Independent sample rate, record length and timebase settings

Make sure youhave therightsample rate for yourmeasurement. While most oscilloscopes restrict sample rate and memory with timebase settings, MXO oscilloscopes offer both automated and manual sample rate controls, record lengths and timebases that are all independent of each other.







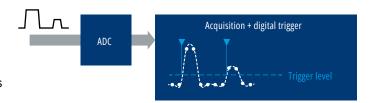
DIGITAL TRIGGER

GREATERTRIGGER SENSITIVITY, REDUCED JITTER, WIDERFILTERING OPTIONS

- ► Single signal path
- ▶ Industry's most precise and sensitive trigger
- ► Adjustable digital trigger filters

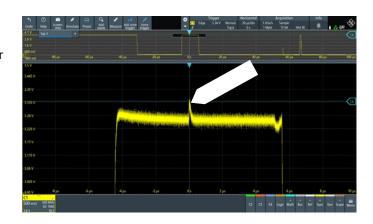
Single signal path

The digital trigger, pioneered and patented by Rohde & Schwarz, uses a single signal path for measurement and triggering. Older analog triggers that have separate measurement and trigger paths with limitations. Users cannot see the actual trigger circuit signal, trigger levels are restricted and noise reduction is severely limited. MXO digital triggering enables faster and more precise triggering.



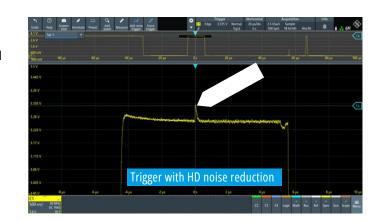
Most precise and sensitive trigger

Isolate small changesin the presence of large signals with trigger sensitivity down to 0.0001 vertical divisions. Trigger precisely on any analog level with interpolated based trigger detection between ADC samples. MXO oscilloscopes have an industry best < 1 ps trigger jitter for additional precision. Minimum trigger re-arm time is just 21 ns compared to other oscilloscopes with a rearm time in the microseconds.



Adjustable digital trigger filters

Use18-bitHD mode to suppress broadband noise. Unlike conventional oscilloscopes where the filter is only applied to the signal path and not the trigger path, MXO oscilloscopes allow for both HD and bandwidth filters. A single path for triggering and measurement means the oscilloscope trigger can turn precisely on/off the signal that is used as a filter.







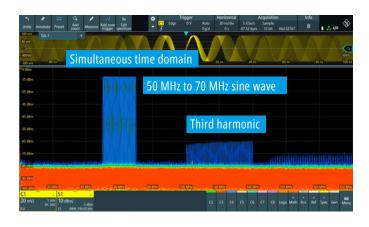
SPECTRUM

FAST AND PRECISE FREQUENCY DOMAIN MEASUREMENTS

- ► Fast: up to 50 000 FFTs/s
- ▶ Independent of time domain settings
- ► Free run for effective harmonics and EMI debugging

Fast: up to 50 000 FFTs/s

MXOspectrum is hardware accelerated. Up to 50 000 FFTs/s make for fast and accurate frequency domain analysis. The analysis bandwidth matches the oscilloscope frequency (max. 1 GHz) and up to four spectra can be used simultaneously.



Independent of time domain settings

Unlikeother oscilloscopes where time and frequency controls are subordinate, MXO 3 spectrum settings are independent of time domain settings, so both time and frequency events are easy to see simultaneously. Select CF/span or start/stop as with a spectrum analyzer. Choose your window type and adjust the realtime bandwidth (RBW) if needed. Use averaging, peak list, max. hold and other spectrum settings.



Free run for effective harmonics and EMI debugging

MXO 3 includes a specialtriggerless free run mode for frequency domain debugging. Maximize FFTs/s for faster signal build-up. Quickly see spurs, harmonics and other frequency domain signals. Combine with a near-field probe for EMI emission debugging. CF/span/RBW can be adjusted to match EMI test needs.







SUPERIOR USER INTERFACE

R&S®SmartGrid UI DESIGNED FOR HIGH PRODUCTIVITY

- ► Customizeyour layout,fast
- ▶ Quick access to settings and capabilities
- ► Short learning curve

Customize your layout, fast

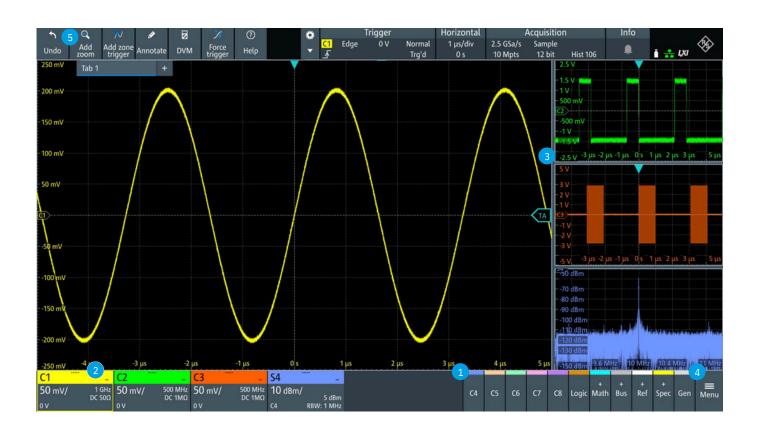
- 1 Tap to turn on sources and other functions
- 2Quickly customize your display layout with drag & drop using R&S®SmartGrid
- 3 Adjust grid and result table boundaries using sliders

Quick access to settings and capabilities

- 4 Easily navigate to all settings using the main menu
- 5 Quickly access important tools with the customizable toolbar

Short learning curve

The MXO user interface is intuitive for those with oscilloscope experience. For those needing a function description or who only occasionally use oscilloscopes, simply press the help button on the toolbar for a description of the function and the SCPI command.







INTUITIVE USER INTERFACE

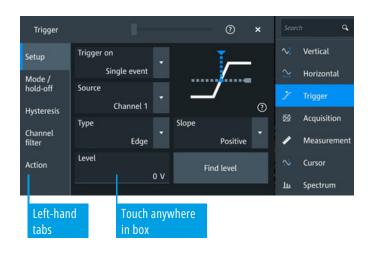
FAST, EASY AND SMART

- ► Left-handtabmaximizes waveformarea
- ► Quickly customize your toolbar
- ▶ Fast search

Left-hand tab maximizes waveform area

The MXO user interfacewas designed using extensive user feedback, competitive comparisons and research into the latest user interface concepts outside of test and measurement:

- ▶ Dialog has left-hand tab design maximize waveform viewing
- ► Anywhere-in-box touch allow you to activate a field by touching a large target area



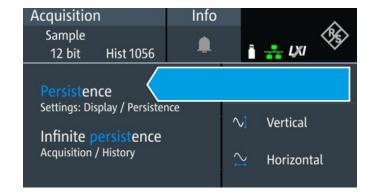
Quickly customize your toolbar

The MXOtoolbarhasquick toolbar access. Pick from a wide range of available tools to customize the display.



Fast search

MXOoscilloscopes pioneered menu search integration. Simply start typing the setting you want and linked list appears. Simply tap on your item for instant navigation.



+33(0)2 99 14 69 65





ZONE TRIGGER

GETINFINITEOSCILLOSCOPE TRIGGER TYPES WITH ZONE TRIGGERING

- Drawto trigger
- Trigger in the frequency domain
- ► Trigger on math waveforms

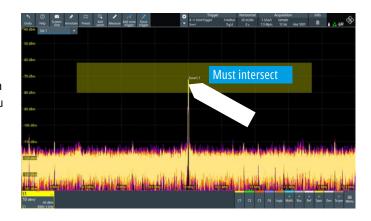
Draw to trigger

Zonetriggering quickly creates triggers that are impossible for traditional types. Simply draw where a signal should or should not intersect. Hardware acceleration means the MXO zone trigger can react to up to 600 000 events/s for an average blind time of 1.6 µs, far shorter than the zone triggering blind times on other oscilloscopes.



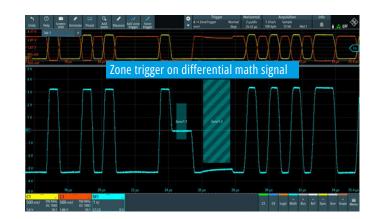
Trigger in the frequency domain

TheRohde & Schwarz zonetrigger works in both the time domain and frequency domain or across both. Use zone triggering for EMI debugging to see what tones exceed certain power levels. Interestingly, zone triggering works in free run mode for a fast 50 000 FFTs/s. The speed lets you quickly and easily see small details and dynamic changes that other oscilloscopes miss.



Trigger on math waveforms

The Rohde & Schwarz zonetrigger also works on math waveforms. Trigger on power (current × voltage) or other math functions. Math triggering can be used independently or combined with zone triggering on individual sources.







MXO 3 Series AT A GLANCE









Integrated arbitrary waveform generator

- ► 50 MHzarbitrary waveform generator
- ► Wide range of waveforms and modulation types
- ► Easy configuration of frequency, amplitude, offset and noise

Clear orientation with color-coded LEDs

- Color-codedkeys androtaryknobsforfast correlation with signal sources
- ► Shows currently selected channel
- ► Simple election between fine/course adjustment

Interface on instrument side

► MSO logic probe connectors



Intuitive front panel increases productivity

- ► Fast, directaccesstoprimary instrument settings
- ► Quickly adjust settings with knobs and keys
- ► Sectional layout makes finding the right function easy





SERIAL BUS TRIGGER AND DECODE

SERIAL BUS TRIGGER AND DECODE OPTIONS

Triggering and decoding for a wide range of serial buses

Choose from one or more of the MXO 3 serial bus trigger and decode options. The options convert physical layer digital or analog waveforms into packets for specific buses. MXO 3 supports a wide range of serial buses and as your bus support needs change, the MXO 3 has you covered. MXO 3 allows up to four simultaneous serial bus decodes all time correlated in the waveform area.



Fast decode with multiple views

Easily see dynamic bus activity with hardware- accelerated decode. View bus packets in the main waveform window, in a time-correlated zoom window or a listing table. Expand the table view with a slider. Select a specific decode table row to see additional packet details in the lower right side of the table.



Trigger at the packet level

Each supported busalso includes packet-level triggering. Hardware based triggering analyzes packet fields in real time and you can specify a packet-level trigger. Software based triggers search each acquisition and stop the instrument when the acquisition includes the specified trigger event.



Trigger and decode packages

Option	Description	Buses
R&S®MXO3-K510	low speed serial buses	I2C/SPI/UART/RS-232/RS-422/RS-485/NRZ clocked/NRZ unclocked/Manchester
R&S®MXO3-K520	automotive buses	CAN/CAN FD/CAN XL/LIN/SENT
R&S®MXO3-K530	aerospace protocols	ARINC 429/MIL-STD-1553/SpaceWire
R&S®MXO3-K550	MIPI low speed protocols	SPMI/RFFE/I3C
R&S®MXO3-K560	automotive Ethernet buses	10BASE-T1S





LOGIC ANALYSIS (MSO)

ADD LOGIC ANALYSIS TO YOUR OSCILLOSCOPE

Built-in logic analysis

Every MXO 3 seriesoscilloscope is enabled for MSO logic analysis. Just add the R&S®MXO3-B1 mixed signal option for 16 digital channels.



Timing relationships and serial bus test

Capture long periodswhileretaining a fast sample rate of up to 5 Gsample/s with 125 Mpoints of memory per logic channel. Use the MSO to see precise timing relationships or to trigger and decode serial buses such as the I2C here on the left.





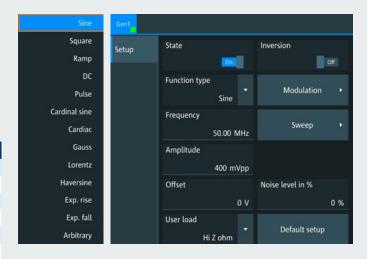


ARBITRARY WAVEFORM GENERATOR

Function and arbitrary waveform generator

Add an integrated 50 MHz arbitrary waveform generator with the R&S®MXO3-B6 option. Choose from a variety of wave shapes or load your own arbitrary waveform file. The modulation feature lets you explore advanced signal variations.

R&S®MXO3-B6 arbitrary waveform generator option		
Analog output	1 output with 50 Ω or 1 $M\Omega$ selection	
Maximum frequency	50 MHz	
Arbitrary waveform length	128 ksample	
Maximum sample rate	312.5 Msample/s	
Vertical resolution	14 bit	
sine, square, ramp, DC, pulse, cardinal sine, cardiac, Gauss, Lorentz, haversine, exponential rise/fall, arbitrary)		
Modulation and sweep	PWM on square, AM, FM, FSK on sine, frequency sweep on sine	



FREQUENCY RESPONSE ANALYSIS WITH BODE PLOT

Add the R&S®MXO3-K36 frequency response analysis option for frequency response analysis (FRA). Characterize the frequency response of various electronic devices for CLS, PSRR and more testing.

Measure phase and gain margins. Configure the amplitude output level during testing. Save screenshots, table results or both for reporting and documentation. FRA calibration data can be saved for future testing.



R&S®MXO3-K36 frequency response analysis option		
Note: R&S®MXO3-B6 is a prerequisite for FRA applications.		
Frequency range Amplitude mode Amplitude level Test 10 mHz to 50 MHz		
points	fixed or amplitude profile	
10 mV to 10 V into high Z; 5 mV to 5 V into 50 Ω		
	10 points to 500 points per decade	

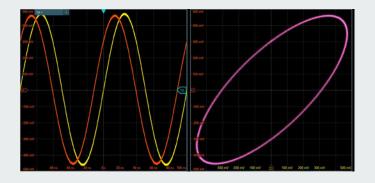




XY MODE, MASK TEST AND DIGITAL VOLTMETER

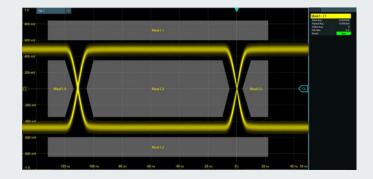
Hardware-accelerated XY mode

Use XY mode to quickly see the graphic relationship between two signals. Hardware accelerated XY means you get up to 600 000 plots/s, similar or faster than analog oscilloscopes. Use XY mode to plot Lissajous and IV curves. Select any channel, math or track signals as sources to plot. Looking for an entertaining hobby? Check out oscilloscope music and oscilloscope art in XY mode and try it out with an MXO 3.



Fastest mask test

Quickly determine how well your signals conform to physical layer requirements. The instrument provides a statistical record of all waveforms that pass and/or fail the mask test. Hardware-accelerated mask testing is among the fastest in the industry. Mask testing supports up to 4 million mask tests/s as well as single-channel and multichannel testing.



Digital voltmeter (DVM)

Want a quick check of DC values? The digital voltmeter updates even when the channel is turned off. Dock the results on either side or at the bottom of the display. Each DVM per channel shares a global configurable measurement bandwidth and time period.



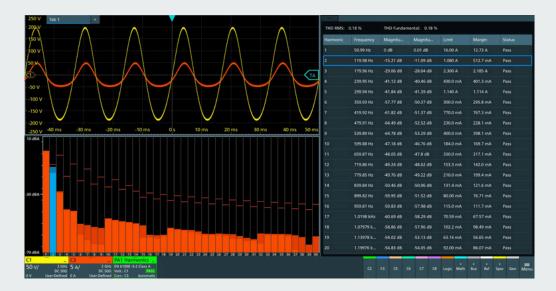




POWER ANALYSIS

Characterizing input power quality

The R&S®MXO3-K31 power analysis option enables power quality measurements and provides concurrent analysis of three pairs of voltage and current sources. The option removes the many manual and tedious calculations needed to determine the real, apparent and reactive power.



Harmonic current analysis in line with standards

AC powersuppliesmust meet different standards for limiting harmonic current. Identifying distortion from harmonic content can be tedious without the right tool. The R&S®MXO3-K31 includes current harmonic analysis for testing in line with all common standards. You can setup three concurrent harmonic measurements.



R&S®MXO3-K31 power analysis option		
Power quality	active, apparent and reactive power, crest factor and phase angle	
Current harmonics	THD RMS and fundamental functions, in line with EN 6100-3-2 classes A, B, C, D, MIL-STD-1399 and RTCA DO-160	
Switching loss	automated measurement for power devices identifying turn on, turn-off, conduction and non-conduction region	
Turn on/off time	measure time taken for device to transition from their on/off state to another	
More analysis functions will be added in future		





REMOTE CONTROL AND CONNECTIVITY

ANYTIME, ANYWHERE.

Easy remote access

Remotely control the oscilloscope and view its display on your web browser and VNC viewer with the same user interface as the instrument, including the front panel. Mount a network drive for storage.



WebDAV support

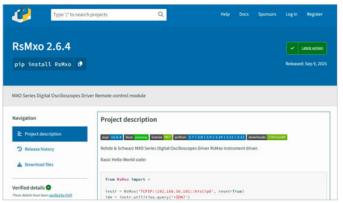
You can easily access instrument data with the web-distributed authoring and versioning (WebDAV) protocol to share, copy, move and edit files on the instrument through a web server. A WebDAV client can be a file transfer client or file manager such as Dolphin or Nemo in Linux, Finder in Mac OS X and File Explorer in Windows. The clients are all capable of accessing the device through IP addresses or device hostnames.

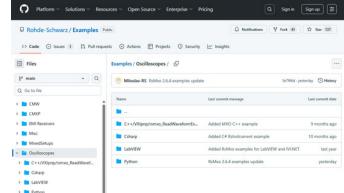
Remotely control using LabView, and python drivers

Alloscilloscopefunctions can be accessed remotely via Ethernet or USB-TMC interface. LabVIEW, VXI, C# and Python instrument drivers are also available, for which sample codes can be found on GitHub and PyPi websites.

```
# SYSTem:DISPlay:UPDate ON
mxo.system.display.set_update(True)
# TRIGger:MODE AUTO
mxo.trigger.set_mode(trigger_mode=TriggerMode.AUTO)
# ACQuire:SRATe:MODE AUTO
mxo.acquire.sampleRate.set_mode(sample_rate_mode=AutoManualMode.AUTO)
```

```
Relevant links
github.com/Rohde-Schwarz/ Examples/tree/main/Oscilloscopes
plugins. jetbrains.com/plugin/19828-rohde--schwarz-instrument-connectivity
pypi.org/project/RsMxo/
www.nuget.org/packages/RsMxo
RsMxo.readthedocs.io/
```









FIRMWARE UPDATES AND SECURITY

Rohde & Schwarz closed-system Linux OS

MXO incorporates a closed Linux operating system for more equipment security. Created and maintained by Rohde & Schwarz, the operating system has been hardened by the company for use across a wide range of Rohde & Schwarz instruments. No external applications or scripts can be executed in the system for a high security level that corporate IT teams can work with.





Regular firmware updates that are free

Regularfirmwareupdates add new functions to MXO 3 oscilloscopes. Download the latest firmware version at www.rohde-schwarz.com. Use a USB storage device or LAN connection for installation.





Software based upgrades

Easy-to-install softwarelicenses upgrade memory, turn on additional serial bus trigger and decode options, enable the generator, digital channels and the frequency response analysis (Bode plot). Upgrade bandwidth with a software license.





Secure erase for media sanitization

Working ina high-security environment? The MXO 3 includes media sanitization procedures in line with NIST Special Publication 800-88: Guidelines for Media Sanitization. Find instructions in the MXO 3 instrument security procedures document.



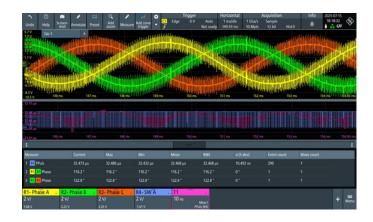






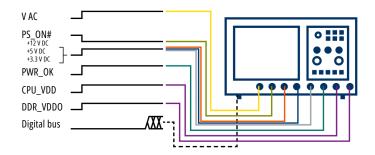
KEY APPLICATIONS

CombineMXO 3 with current probes, high voltage probes and/or optically isolated probes for power electronic measurements. The MXO 3 excels in power electronic measurements with HD mode noise suppression, rich math and 8-channel models.



PMIC, power integrity and sequencing

With its industry-best high offset, low noise and extensive time and frequency domain capabilities, MXO 3 excels in a variety of power measurements. Combine with an R&S®RT-ZPR power rail probe for excellent power integrity measurements. Use with passive probes for power sequencing testing. Use for voltage regulator and other on-board power tests.



Embedded hardware testing

The MXO 3 putsbig capabilities in a small form to excel at a variety of embedded hardware development testing needs. These include board bring up, hardware integration testing and software hardware integration tasks. The MXO 3 has robust capabilities for embedded hardware manufacturing and troubleshooting and repair.





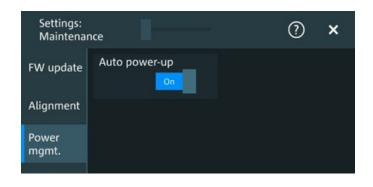


QUIET AND SUSTAINABLE PERFORMANCE

KEEP POWER CONSUMPTION IN CHECK

Reduce power consumption

Reducing power consumption is important now and will be in the future. The electrical power used over the lifecycle of an electronic device can make up 90 % of its CO 2 footprint. Minimizing power consumption reduces the environmental impact of an oscilloscope. Rising energy prices make reducing power consumption essential to long-term affordability.



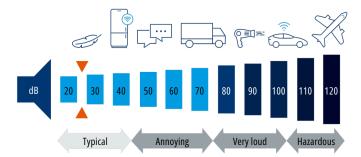
Remotely turn on/off your Rohde & Schwarz oscilloscope

When working remotely, keeping theunit powered inthe lab 24/7 can waste a lot of energy. While remote IP controlled socket power supplies are possible, most electronic equipment will only power up to a standby state with the main power switched on. The MXO 3 provides a convenient feature that allows it to be turned on automatically as soon as electric power is switched on. By simply connecting it into a smart socket system, you can enable the option of remotely turning on the device only when you intend to use it, while keeping it powered off at other times.



Peace and quiet

Need aquiet space? Do loud instruments or loud equipment disturb others? The MXO 3 series has a very low operating audible noise level and sounds like a soft whisper. You might not even notice that it's turned on.





EXTENSIVE PROBE PORTFOLIO

THE RIGHT PROBE FOR THE YOUR MEASUREMENT

MXO 3 oscilloscope comes standard with one 700 MHz passive probe for each channel. Choose from a comprehensive portfolio of high-quality passive and active probes from Rohde & Schwarz for other probe needs



Complete portfolio for power measurements

The portfolio of dedicated probes for power measurements includes active and passive probes for different voltage and current ranges – from μA to kA and from μV to kV. Dedicated power rail probes can detect small and sporadic distortions on DC power rails. High voltage differential probes allow isolated floating measurements.

High voltage differential probes

The R&S®RT-ZHD serieshighvoltage differential probes have an excellent common mode rejection ratio (CMRR) for a broad frequency with 200 MHz bandwidth and can safely measure up to 6000 V peak voltage. Low noise makes it an ideal probe for switching power analysis with ground reference.

Micro button and R&S®ProbeMeter for easy control

Our active probes feature amicro button, cleverly located on the probe tip. You can assign various functions to the micro button, such as run/stop, autoset and adjust offset to directly control the oscilloscope from the probe.

Most Rohde & Schwarz active probes come with the R&S®ProbeMeter that takes precision to a whole new level. The probes impressive accuracy of 0.1 % ensures reliable and trustworthy measurements. When Rohde & Schwarz designs a probe, thermal drifts, filters and usability are usually the best overall. Make measurements a breeze and get precise results with confidence.





+33(0)2 99 14 69 65

Rohde & Schwarz has a comprehensive probe portfolio to meet every probing need.

► For more information, see product brochure "Probes and accessories for Rohde & Schwarz oscilloscopes" (PD 3606.8866.12)



Passive probes included as standard (38 MHz to 700 MHz)

R&S®RT-ZP11, R&S®RT-ZP1X

Passive probes come standard with every Rohde & Schwarz oscilloscope. They are low cost, general purpose probes for a broad range of applications.



Passive broadband probes (8 GHz)

R&S®RT-ZZ80

These are an economical yet powerful alternative to active probes for measuring high speed signals on low impedance lines. They feature extremely low input capacitance, very low noise and high linearity.



Active single-ended broadband probes (1 GHz to 6 GHz)

R&S®RT-ZS10E, R&S®RT-ZS10, R&S®RT-ZS20, R&S®RT-ZS30, R&S®RT-ZS60

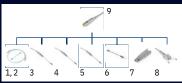
A very high dynamic range and exceptionally low offset and gain errors combined with the right accessories make these probes ideal for Rohde & Schwarz oscilloscopes.



Active differential broadband probes (1 GHz to 4.5 GHz)

R&S®RT-ZD10, R&S®RT-ZD20, R&S®RT-ZD30, R&S®RT-ZD40 and R&S®RT-ZA15 external attenuator

A flat frequency response and high input impedance with low input capacitance permit precise measurements on differential signals while maintaining a low load on the DUT. The CMMR for the entire probe bandwidth has high interference immunity.



1 R&S®RT-ZMA50; 2 R&S®RT-ZMA11; 3 R&S®RT-ZMA10; 4 R&S®RT-ZMA12; 5 R&S®RT-ZMA15; 6 R&S®RT-ZMA14; 7 R&S®RT-ZMA30; 8 R&S®RT-ZMA0; 9

Modular broadband probes (1.5 GHz to 16 GHz)

R&S®RT-ZM15, R&S®RT-ZM30, R&S®RT-ZM60, R&S®RT-ZM90, R&S®RT-ZM130, R&S®RT-ZM160

Current probing requirements need a technically sophisticated, yet easyto-handle solution. The various probing solutions meet the demands for high probe bandwidths and dynamic range along with the need for low capacitive load.



R&S®RT-ZM

Power rail probes (2 GHz and 4 GHz)

R&S®RT-ZPR20. R&S®RT-ZPR40

Wide bandwidth, high sensitivity, very low noise and extra-large DC offset make these probes an excellent tool for characterizing power rails. The integrated high-precision DC voltmeter (R&S®ProbeMeter) provides instantaneous DC voltage readout.



High voltage probes (100 MHzto 400 MHz;±750 Vto±6000 V)

R&S®RT-ZH03, R&S®RT-ZH10, R&S®RT-ZH11, R&S®RT-ZHD07, R&S®RT-ZHD15, R&S®RT-ZHD16, R&S®RT-ZHD60

The Rohde & Schwarz portfolio of high voltage probes includes passive single-ended and active differential probes for up to 6000 V (peak). Different models allow measurements in up to CAT IV environments. Differential probes provide exceptional common mode rejection over a wide bandwidth.



Current probes (20 kHz to120 MHz;±1mAto±2000A)

R&S®RT-ZC02, R&S®RT-ZC03, R&S®RT-ZC05B, R&S®RT-ZC10, R&S®RT-ZC10B, R&S®RT-ZC15B, R&S®RT-ZC20, R&S®RT-ZC20B, R&S®RT-ZC30, R&S®RT-ZC31

Rohde & Schwarz current probes enable accurate, non-intrusive measurements of DC and AC currents. Different models are available to measure currents in the range from 1 mA to 2000 A with a bandwidth of up to 120 MHz. Current probes are available with the Rohde & Schwarz probe interface or a BNC connector for an external power supply.



EMC near-field probes (30 MHz to 3 GHz) R&S®HZ-15, R&S®HZ-17

Powerful E and H near-field probes for the frequency range from 30 MHz to 3 GHz with an optional preamplifier expand the application range of the MXO 5 series oscilloscope to include EMI debugging.



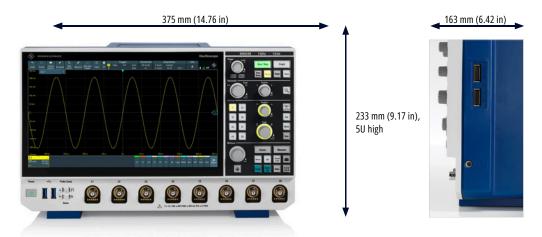


ACCESSORIES AND RACKMOUNT

Safe transport and easy rack mounting

An extensive selection of storage and transportation accessories means the MXO 3 series oscilloscopes are always fully protected and easy to transport. The rackmount kit allows easy installation of the oscilloscope in integrated environments.









THE MXO SERIES



FAST AND PRECISE





SPECIFICATIONS OF BASE UNIT

	4 channels or 8 channels
	50 Ω ± 1.5 %,
	1 M Ω ± 1 % 12 pF (meas.)
MXO 34, 4-channel instrument	
at 50 Ω input impedance	
MXO 3 MXO 3 with -B242	≥ 100 MHz
option MXO 3 with -B243	≥ 200 MHz
option MXO 3 with -B245	≥ 350 MHz
option MXO 3 with -B2410	≥ 500 MHz
option	≥ 1 GHz
at 1 MΩ input impedance	
MXO 3 MXO 3 with -B242	≥ 100 MHz (meas.)
option MXO 3 with -B243	≥ 200 MHz (meas.)
	≥ 350 MHz (meas.)
·	≥ 500 MHz (meas.)¹)
	≥ 500 MHz (meas.) ¹⁾
	_ 555 (515)
	≥ 100 MHz
	≥ 200 MHz
	≥ 350 MHz
· ·	≥ 500 MHz
	≥ 1 GHz
	2 1 GHZ
· · · · · · · · · · · · · · · · · · ·	
	≥ 100 MHz (meas.)
	≥ 200 MHz (meas.)
	≥ 350 MHz (meas.)
	≥ 500 MHz (meas.) 1)
option	≥ 500 MHz (meas.) 1)
	500/350/200/100/50/20 MHz (meas.)
10 % to 90 % at 50 O	
	< 3.5 ns
	< 1.75 ns
	< 1 ns <
·	700 ps <
	350 ps
	330 ps
	125
	< 3.5 ns
	< 1.75 ns
·	<1 ns
	< 700 ps
option	< 350 ps
	12 bit,
	up to 18 bit for high definition mode 1 mV/div to 1 V/div,
at 50 Ω	entire analog bandwidth supported for all input sensitivities
at 1 M Ω	1 mV/div to 10 V/div, entire analog bandwidth supported for all input sensitivities
offset and position set to 0 V after self-alignme	
	±1 % full scale
	±1.5 % full scale
input scholavity = 3 inv/div to = 1 inv/div	LI.J /0 Tutt Scale
at E0.0	DC .
at $50~\Omega$ at $1~M\Omega$	DC DC, AC (> 7 Hz)
	at 50 Ω input impedance MXO 3 MXO 3 with -B242 option MXO 3 with -B243 option MXO 3 with -B245 option MXO 3 with -B2410 option at 1 MΩ input impedance MXO 3 MXO 3 with -B242 option MXO 3 with -B243 option MXO 3 with -B245 option MXO 3 with -B2410 option MXO 38, 8-channel instrument at 50 Ω input impedance MXO 3 MXO 3 with -B282 option MXO 3 with -B283 option MXO 3 with -B2810 option at 1 MΩ input impedance MXO 3 MXO 3 with -B2810 option at 1 MΩ input impedance MXO 3 MXO 3 with -B282 option MXO 3 with -B283 option MXO 3 with -B283 option MXO 3 with -B283 option MXO 3 with -B284 option MXO 3 with -B285 option MXO 3 with -B285 option MXO 3 with -B2810 option 10 % to 90 % at 50 Ω MXO 34, 4-channel instrument MXO 3 MXO 3 with -B242 option MXO 3 with -B242 option MXO 3 with -B242 option MXO 3 with -B243 option MXO 3 with -B242 option MXO 3 with -B242 option MXO 3 with -B243 option MXO 3 with -B245 option MXO 3 with -B2410 option MXO 38, 8-channel instrument MXO 3 MXO 3 with -B282 option MXO 3 with -B283 option MXO 3 with -B283 option MXO 3 with -B285 option MXO 3 with -B2810 option at 50 Ω

 $^{^{\}scriptscriptstyle 1)}~$ With R&S®RT-ZP05M passive probe.





Vertical system: analog channels					
Maximum input voltage	at 50Ω		5 V (RMS), 30 V (V p)	
			300 V (RMS), 400 V	1.77	>
	at 1 MΩ		derates at 20 dB/de 250 kHz	cade to 5 V (RN	1S) above
			400 V (RMS), 1650 V	V (V n)	
			300 V (RMS) CAT II;		
	at 1 MΩ with R&S®RT-ZP0	5M passive probe	for derating and det		T-Zxx
			Standard Probes spe	ecifications	
B 44			(PD 3607.3851.22) ±5 div		
Position range	inni dan majali jih j		±5 uiv		
Offset range at 50 Ω	input sensitivity		1201/		
	70 mV/div to 1 V/div		±20 V ±3 V		
Offset range at 1 $M\Omega$	1 mV/div to < 70 mV/div input sensitivity		±3 V		
Offset range at 1 PM2	1 V/div to 10 V/div		±250 V		
	60 mV/div to < 1 V/div		±30 V		
	1 mV/div to < 60 mV/div		±3 V		
	I my aiv to 1 00 my aiv		±(0.35 % × net offs	etl + 0.5 mV +	
Offset accuracy			0.1 div × input sensi	•	
			(net offset = offset -	position × inp	ut sensitivity)
	after adequate suppression		±(DC gain accuracy	× reading – ne	t offset +
DC measurement accuracy	noise using high definition		offset accuracy)		
Channel-to-channel isolation	form averaging or a combi				
(each channel with same input sensitivity)	input frequency within ins	trument bandwidth	> 60 dB (1:1000)		
RMS noise floor 2)					
At 50 Ω (meas.)	Input sensitivity	Analog bandwidth (-	3 dB)		
711 00 12 (modo.)	,	100 MHz 200 N		500 MHz	1 GHz
	1 mV/div 2	50 μV 53 64 μV	' 68	83 µV 88	136 μV
	mV/div 5	μV 64 μV μV 78	μV μV 92 μV	μV 101	143 μV
	mV/div 10	91 μV 107	μV 121 μV	μV 133	166 μV
	mV/div 20	156 μV 174	μV 195 μV	μV 213	224 μV
	mV/div 50	380 μV 418	μV 468 μV	μV 516	371 μV
	mV/div 100	923 μV 1.06		μV 1.31	901 μV
	mV/div 200	1.60 mV 1.76		mV 2.12	2.01 mV
	mV/div 500	3.69 mV 3.96		mV 4.75	3.46 mV
	mV/div 1 V/div	7.28 mV 7.82 r	mV 8.50 mV	mV 9.30	8.00 mV
114110/	Input		o ID)	mV	15.77 mV
At 1 M Ω (meas.)	sensitivity	Analog bandwidth (-		250 MH-	500 MH-
	1 m\//div 2	20 MHz 100		350 MHz	500 MHz
	1 mV/div 2 mV/div 5	35 μV 34 46 μV μV 47 μV μV 60		62 μV 66	65 μV 70 μV 88 μV
	mV/div 10	μV 47 μV μV 60 74 μV 138 88 μV		μV 81 μV 118 μV	μν 88 μν 129 μV 226
	mV/div 20	μν 334 μν μν 37	·	205 μV	μV 524 μV
	mV/div 50	715 μV 849	μV 422 μV	477 μV	1.23 mV
	mV/div 100	1.37 mV 1.56		1.13 mV	2.21 mV
	mV/div 200	3.37 mV 3.76	mV 1.79 mV	2.02 mV	5.20 mV
	mV/div 500	7.08 mV 8.29		4.77 mV	12.05 mV
	mV/div 1	13.78 mV 15.70		11.18 mV	22.39 mV
	V/div 2	34.20 mV 37.64		20.40 mV	52.09 mV
	V/div 5	68.50 mV 75.54		48.16 mV	104.25 mV
	V/div 10		85.48 mV	96.27 mV	
	V/div				

 $^{^{2)}}$ HD mode active for bandwidth \leq 500 MHz.





Vertical system: digital channels		
Input channels		16 logic channels (D0 to D15)
Arrangement of input channels		arranged in two logic probes with 8 channels each, assignment of the logic probes to the channels (D0 to D7 and D8 to D15) is displayed on the probe
Input impedance		100 kΩ \pm 2 % ~4 pF (meas.) at probe tips
Maximum input frequency	signal with minimum input voltage swing and hysteresis setting: "normal"	300 MHz (meas.)
Maximum input voltage		±40 V (V p); 32 V (RMS), derates to 7 V (RMS) with 20 dB/decade at frequencies above 25 MHz
Minimum input voltage swing		500 mV (Vpp) (meas.)
Threshold groups		D0 to D3, D4 to D7, D8 to D11 and D12 to D15
Threshold level	range	±8 V in 25 mV steps
	predefined	CMOS 5.0 V, CMOS 3.3 V, CMOS 2.5 V, TTL, ECL, PECL, LVPECL
Threshold accuracy	threshold level between ±4 V	±(100 mV + 3 % of threshold setting)
Comparator hysteresis		normal, robust, maximum
Horizontal system		
Tionzontat system		selectable between 200 ps/div and 10 000 s/div.
Timebase range		time per div settable to any value within range
Deskew range (channel deskew)	between analog channels	±20 ms
-	between digital channels	±100 ns
Reference position		0 % to 100 % of measurement display area
Horizontal position range (trigger offset range)	max.	+(memory depth/current sampling rate)
	min.	-5000 s
Modes		normal, roll
Channel-to-channel skew	between analog channels	< 100 ps (meas.)
	between digital channels	< 500 ps (meas.)
Timebase accuracy	after delivery/calibration, at +23 °C	±2.5 ppm
	during calibration interval	±3.5 ppm
	corresponds to time error between two edges on	
Delta time accuracy	same acquisition and channel; signal amplitude greater than 5 divisions, measurement threshold ±	c(0.20/real-time sampling rate +
Detta time accuracy	set to 50 %, vertical gain 10 mV/div or greater; rise time lower than four sample periods; waveform acquired in real-time mode	timebase accuracy × reading) (peak) (meas.)
	.,	
Acquisition system		
Sampling rate	analog channels (real time)	
Campails rate		max. 5 Gsample/s on 2 channels,
	MXO 34	max. 2.5 Gsample/s on 4 channels
	MXO 38	max. 5 Gsample/s on 4 channels, max. 2.5 Gsample/s on 8 channels
	analog channels (interpolated)	max. 5 Tsample/s
	digital channels	max. 5 Gsample/s on each channel
Waveform acquisition rate	max.	> 4 500 000 waveforms/s
Trigger rearm time	min.	< 21 ns
Memory depth 3)	standard	125 Mpoints
	R&S®MXO34-B105 option	500 Mpoints with 4 active channels (single capture), 500 Mpoints with 2 active channels (run continuous)
	R&S®MXO38-B105 option	500 Mpoints with 8 active channels (single capture), 500 Mpoints with 4 active channels (run continuous)

³⁾ The maximum available memory depth depends on the bit depth of the acquired data and, therefore, on the settings of the acquisition system, such as decimation mode, waveform arithmetic or high definition mode.





Acquisition system		
Acquisition modes	sample	middle sample in decimation interval
	peak detect	largest and smallest sample in decimation
	average	interval
	number of averaged waveforms	average of acquired waveforms
	envelope	2 to 16 777 215
	real-time mode interpolated time	envelope of acquired waveforms
Sampling modes		max. sampling rate set by digitizer
		enhancement of sampling resolution by interpo-
		lation; max. sampling rate is 5 Tsample/s
Interpolation modes		linear, sin(x)/x, sample & hold
Fast segmentation mode	continuous recording of waveforms in acquis	ition memory without interruption due to visualization
	max. real-time waveform acquisition rate	> 4 600 000 waveforms/s
	min. blind time between consecutive acquisitions	< 21 ns
	acquisitions	
High definition mode		
	The high definition mode increases the bit re	solution of the waveform signal by using digital filter-
General description	ing, leading to reduced noise. Because of the increased numeric resolution are used as the	digital trigger concept of the MXO 3, signals with input for triggering.
Numeric resolution	bandwidth, at 5 Gsample/s	bit resolution
	1 kHz to 10 MHz	18 bit
	100 MHz	16 bit
	200 MHz	15 bit
	500 MHz	14 bit
B. Life and the second	111/0 0 4	max. 5 Gsample/s on 2 channels,
Real-time sampling rate	MXO 34	max. 2.5 Gsample/s on 4 channels
	MXO 38	max. 5 Gsample/s on 4 channels,
	MAO 36	max. 2.5 Gsample/s on 8 channels
Trigger system		
		analog channels (C1 to C4),
Trigger sources		digital channels (D0 to D15),
		external trigger input, line trigger, serial bus
Trigger level range		±5 div from center of screen
Trigger modes		auto, normal, single, n single
Trigger sensitivity		0.0001 div, from DC to instrument bandwidth for
		all vertical scales < 1 ps (RMS) (meas.)
Trigger jitter	full-scale sine wave of frequency set to	same as selected channel
56 .	-3 dB bandwidth	cutoff frequency selectable from 1 kHz to
Coupling mode	standard	500 MHz '
	HF reject	attenuates frequencies < 50 kHz
	LF reject	auto (default setting) or manual 0.0001 div, from DC to instrument bandwidth for
Tologou books as als	modes adjustment resolution	all vertical scales
Trigger hysteresis	time	100 ns to 10 s, fixed and random
Holdoff range		
Main trigger modes		
Edge	triggers on specified edge (positive, negative	
Glitch	triggers on glitches of positive, negative or ei- width	ther polarity that are shorter or longer than specified
	glitch width	200 ps to 1000 s
	triggers on positive or negative pulse of speci side a specified range	ified width; width can be shorter, longer, inside or out-
Width		
Width	pulse width	200 ps to 1000 s
Width	triggers on pulse of positive, negative or either a second threshold before crossing the first c	er polarity that crosses one threshold but fails to cross one again; runt pulse width can be arbitrary, shorter,
	triggers on pulse of positive, negative or either a second threshold before crossing the first o longer, inside or outside a specified range	er polarity that crosses one threshold but fails to cross one again; runt pulse width can be arbitrary, shorter,
	triggers on pulse of positive, negative or either a second threshold before crossing the first clonger, inside or outside a specified range runt pulse width triggers when signal enters or exits a specifie	er polarity that crosses one threshold but fails to cross one again; runt pulse width can be arbitrary, shorter, 200 ps to 1000 s ed voltage range; triggers also when signal stays inside
Runt	triggers on pulse of positive, negative or either a second threshold before crossing the first clonger, inside or outside a specified range runt pulse width	er polarity that crosses one threshold but fails to cross one again; runt pulse width can be arbitrary, shorter, 200 ps to 1000 s ed voltage range; triggers also when signal stays inside eriod of time





Trigger system				
Interval	triggers when time between two consecutive e longer, inside or outside a specified range	dges of same slope (positive or negative) is shorter,		
	interval time	200 ps to 1000 s		
Slew rate		triggers when the time required by a signal edge to toggle between user-defined upper and lower voltage levels is shorter, longer, inside or outside a specified range; edge slope may be positive, negative or either		
	toggle time	0 ps to 1000 s		
Setup & hold	channels; monitored time interval may be sp	triggers on setup time and hold time violations between clock and data present on any two inpochannels; monitored time interval may be specified by the user in the range from -100 s to 100 around a clock edge and must be at least 200 ps wide		
Pattern		triggers when a logical combination (and, nand, or, nor) of the input channels stays true for a period of time shorter, longer, inside or outside a specified range		
State	triggers when a logical combination (and, nand (positive, negative or either) in one selected ch	l, or, nor) of the input channels stays true at a slope nannel		
Advancedtrigger modes				
Zone trigger	triggers on user-defined zones drawn on the di	isplay		
	source	acquired waveforms (input channels), math waveforms (including power analysis wave- forms), spectrum waveforms, XY plots		
	number of zones/areas	up to 4 zones with up to 8 areas each		
	area shapes	polygons with up to 16 points		
	area types	must intersect, must not intersect		
	combination of zones	logical combination of zones of multiple sources		
		requires sequence trigger A > zone trigger		
	trigger compatibility	where print who sondition can he edge editche, setup & hold, state, pattern		
Sequence trigger (A/B/R trigger)	triggers on B event after occurrence of A event val; an optional R event resets the trigger sequ	; delay condition after A event specified as time interence to A		
	A event	edge, glitch, width, runt, window, timeout, interval, slew rate		
	B event	edge, glitch, width, runt, window, timeout, interval, slew rate		
	R event	edge, glitch, width, runt, window, timeout, interval, slew rate		
Serial bus trigger	optional	see dedicated triggering and decoding options		
Trigger input	input impedance max. input voltage at 50 Ω	50 Ω (meas.) or 1 M Ω (meas.) 11 pF (meas.)		
		30 V (Vp)		
	max. input voltage at 1 $M\Omega$	300 V (RMS), 400 V (V ^{p)} , derates at 20 dB/decade to 5 V (RMS) above 250 kHz		
	trigger level sensitivity	±5 V		
	input frequency ≤ 100 MHz	300 mV (Vpp)		
	input frequency > 100 MHz and ≤ 500 MHz	500 mV (Vimeas.)		
	input requerity > 100 MHz and \$ 500 MHz	AC, DC (50 Ω and 1 M Ω)		
	trigger filter	HF reject (attenuates > 50 kHz), LF reject (attenuates < 50 kHz), noise reject		
	trigger modes	edge (positive, negative or either)		
Trigger output	functionality	A pulse is generated for each event triggering signal acquisition.		
	output voltage	0 V to 5 V (nom.) at high impedance; 0 V to 2.5 V (nom.) at 50 Ω		
	pulse width	selectable between 16 ns and 50 ms		
	pulse polarity	low active or high active		
	output delay	depends on trigger settings		





Spectrum analysis			
General description	Spectrum analysis allows signal analysis in the frequency domain.		
Spectrum	sources	channel 1 to channel 4, math waveforms, reference waveforms	
	setup parameters	center frequency, frequency span, resolution bandwidth (automatic or manual), gate position, gate width, vertical scaling, vertical position	
	scaling	dBm, dBV, dBμV, V (RMS)	
	span	1 Hz to 1.2 GHz 4)	
	resolution bandwidth (RBW) windows	span/4 ≥ RBW ≥ span/6000	
	trace types max. real-time waveform acquisition rate	flat top, Hanning, Hamming, Blackman, rectangular, Kaiser Bessel, Gaussian normal, max. hold, min. hold, average	
		> 40 000 waveforms/s	
Gate delimits the display region used for spectrum analysis		ysis	
Peak list	The values in the peak list are also shown in the diagram to allow easy correlation.		
RF characteristics			
Sensitivity/noise density	at 1 GHz (measurement of the power spectral density at 1 GHz at input sensitivity 2 mV/div, correspond- ing to –30 dBm input range of the oscilloscope, using spectrum analysis with center frequency 1 GHz, span 500 kHz, RBW 3 kHz)	−157 dBm (1 Hz) (meas.)	
Noise figure	at 1 GHz (calculated based on the noise power density above)	16 dB (meas.)	
Dynamic range	measured for a 1 GHz input carrier with level -3 dBm at input of oscilloscope, using spectrum analysis with center frequency 1 GHz, span 2 MHz, RBW 400 Hz at +20 MHz from center frequency	106 dB (meas.)	
Absolute amplitude accuracy	0 Hz to 800 MHz	±1 dB (meas.)	
Spurious-free dynamic range (excluding harmonics)	measured for a 250 MHz input carrier and level –3 dBm at input sensitivity 50 mV/div, using spectrum analysis with center frequency 600 MHz, span 1.2 GHz, RBW 300 kHz	65 dBc (meas.)	

measured for a 250 MHz input carrier and level –3 dBm at input sensitivity 50 mV/div, using spectrum analysis with center frequency

600 MHz, span 1.2 GHz, RBW 300 kHz measured for a 250 MHz input carrier and level –3 dBm at input sensitivity 50 mV/div, using spectrum analysis with center frequency

600 MHz, span 1.2 GHz, RBW 300 kHz

-59 dBc (meas.)

-60 dBc (meas.)

Second harmonic distortion

Third harmonic distortion





⁴⁾ The stop frequency depends on the analog bandwidth of the instrument.

Waveform measurements		
Wave form measurements		amplitude, high, low, maximum, minimum,
Automatic measurements	measurements on acquired waveforms (input channels), math waveforms, reference waveforms	peak-to-peak, mean, RMS, sigma, positive over- shoot, negative overshoot, area, rise time, fall time, positive pulse width, negative pulse width, period, frequency, positive duty cycle, nega- tive duty cycle, delay, phase, burst width, pulse count, edge count, pulse train, positive switch- ing, negative switching, cycle area, cycle mean, cycle RMS, cycle sigma, setup, hold, setup/hold time, setup/hold ratio, slew rate rising, slew rate falling, delay to trigger
	gate	delimits the display region evaluated for automatic measurements
	reference levels	user-configurable vertical levels define support structures for automatic measurements
	statistics	displays maximum, minimum, mean, standard deviation and measurement count for each automatic measurement
	track	measurement results displayed as continuous trace that is time-correlated to the measurement source
	number of active measurements	16
	result line annotation	
Cursor measurements	available cursors	up to two cursor sets on screen, each set with two horizontal and two vertical cursors
	target waveforms	acquired waveforms (input channels), math waveforms, reference waveforms, XY diagrams
	operating modes	vertical measurements, horizontal measure- ments, or both; vertical cursors either set manually or locked to waveform
	source mode	single source, use second source, multiple sources (multichannel cursor)
	multiple sources mode selection	acquired waveforms (input channels), math
Waveform histogram	number of diagrams	waveforms, reference waveforms
	sources	up to 8 acquired waveforms (input channels), math waveforms, reference waveforms
	mode	vertical, horizontal
	windowing	user-defined
May rafa was as ath		
Waveform math	and the second second second	on to Com to Cohomal A should be and
General features	number of math equations	up to 8 up to 8 channel 1, channel 2, channel
	number of reference waveforms sources	channel 4, channel 5, channel 6, channel 7, channel 8, math waveforms 1 to 8, reference waveforms 1 to 8 add subtract, multiply, divide, absolute value, square, square root, integrate, differentiate, log
Functions	operators	loge, log2, reciprocal, invert, low pass, high pass, rescale (a * x+b)
	filter	low pass, high pass
	filter types	Gaussian, rectangular
	gate	delimits the display region used for waveform math
Digital voltmeter		
Accuracy		related to channel settings of voltmeter source
Measurements		DC, DC RMS, AC RMS
Sources		C1, C2, C3, C4, C5, C6, C7, C8
Number of measurements		up to 4
Resolution		up to 6 digits
Bandwidth		up to 20 MHz





Display characteristics	
Diagram types	Yt, XY, zoom, spectrum
Display configuration (waveform layout)	The display area can be split into separate diagram areas by dragging and dropping signal icons. Each diagram area can hold any number of signals. Diagrams can be stacked on top of each other and later accessed via dynamic tabs (Tab 1, etc.).
Signal icons	Each active waveform is represented by a signal icon on the signal bar; the signal icon displays the individual vertical and acquisition settings.
Toolbar	enables quick access to important tools; allows to set the most common parameters directly in a simple menu and gives access to more detailed parameters in the main menu; user-defined selection of tools in the toolbar
Upper menu bar	displays trigger, horizontal and acquisition system settings; allows quick access to these settings
Main menu	provides access to all instrument settings in a compact menu structure
Axis label	The x-axis and y-axis are labeled with values and physical unit.
Diagram label	Diagrams can be individually labeled with a descriptive, user-defined name.
Diagram layout	The grid, crosshair, axis labeling and diagram labeling can be switched on and off separately.
Persistence	50 ms to 50 s, or infinite
Zoom	vertical and horizontal; touch interface simplifies resize and drag operations on zoom window predefined or user-defined color tables for persistence display
Signal colors (waveform coding)	predefined of user-defined color lables for persistence display

Acquisition memory	automatic	automatic setting of segment size and sample		
Acquisition memory	automatic	user-defined setting of segment size and sample		
	manual	rate		
	function			
Memory segmentation	number of segments	memory segments for the acquisition segments 5)		
	ŭ	rectro length 1 RASINF75		
		5346-3497s		
		3 (2) 1/11/2 s		
		10 k p 7 i h ts		
		25 ନି∂ର୍ମints		
		38 K67ints		
		166 R∂oints		
		206 kpoints		
		\$90% points		
		21Mβ oint		
		2 9有6oints		
		\$ ₹7points		
		₹ ₿₩points		
		₹96Mpoints		
		∯ Mpoints		
		₹90 Mpoints		
		200 Mpoints		
		400 Mpoints		
		900 Mpoints		
	Segmentation is available on all ar analysis.	Segmentation is available on all analog and logic channels, protocol decoding and spectrum analysis.		
Fast-segmented mode		continuous recording of waveforms in acquisition memory without interruption due to visualization; blind time between consecutive acquisitions, see Acquisition system		
History mode	function	provides access to past acquisitions in the seg- mented memory		
	timestamp resolution	1 ns		
	history player	replays the recorded waveforms; repetition pos- sible; adjustable speed; manual next/previous segment; numerical segment number input		
	analyze options	overlay all segments, average all segments, envelope all segments		
		-		

⁵⁾ With R&S®MXO3-B105 memory option. The maximum number of segments depends on the number of active channels and the bit resolution of the acquired data and, therefore, on the acquisition system settings such as decimation mode, use of waveform arithmetics or high definition (HD) mode. The maximum number of segments without R&S®MXO3-B105 memory option is limited to 10 000.





Test definition	number of masks	up to 8 simultaneously
	source	acquired waveforms (input channels), math waveforms, reference waveforms, spectrum waveforms, XY plots
	fail condition	waveform hit
	test rate	up to 4 million waveforms/s
	action on error	acquisition stop, beep, save waveform, pulse on trigger out
Mask definition with segments	number of segments per mask test	up to 8
Result statistics	segment definition	array of at least 3 points defines an inner region total completed acquisition, failed acquisition, passed acquisition, fail rate, overall test result (pass/fail)
Visualization antique		vectors, dots
Visualization options	waveform style mask colors	predefined colors for mask without violation (translucent gray), mask with violation (translu- cent red)
Miscellaneous		
Miscendieous		full an austion of the instances of the last
Remote control	web interface	full operation of the instrument's touch interface, keys and multifunction wheel via web browser
	VNC	control of the instrument through virtual network computing
	SCPI	standard instrument programming interface through VISA
Languages	available languages for the user interface	English, German, French, Simplified Chinese, Traditional Chinese, Japanese, Russian, Spanish, Italian, Portuguese, Korean, Czech, Polish
	online help on the instrument	English
Input and output		
Front		
Channel inputs		BNC; for details, see Vertical system
	probe interface	auto detection of passive probes, Rohde & Schwarz active probe interface
	probe interface D15 to D8, D7 to D0	
Digital channel inputs Probe compensation output	·	Rohde & Schwarz active probe interface
Digital channel inputs	D15 to D8, D7 to D0	Rohde & Schwarz active probe interface interface for R&S®RT-ZL03X logic probe rectangle, Vlow = 0 V, Vhigh = 3.3 V
Digital channel inputs	D15 to D8, D7 to D0 signal shape	Rohde & Schwarz active probe interface interface for R&S®RT-ZL03X logic probe rectangle, Vlow = 0 V, Vhigh = 3.3 V amplitude 3.3 V (Vpp) ± 5 % (meas.)
Digital channel inputs Probe compensation output Demo P1	D15 to D8, D7 to D0 signal shape frequency analog signal output for demo apps	Rohde & Schwarz active probe interface interface for R&S®RT-ZL03X logic probe rectangle, Vlow = 0 V, Vhigh = 3.3 V amplitude 3.3 V (Vpp) ± 5 % (meas.) 1 kHz ± 1 % (meas.) V B ≤ ±55 V (meas.) V
Digital channel inputs Probe compensation output Demo P1 Demo P2	D15 to D8, D7 to D0 signal shape frequency analog signal output for demo apps	Rohde & Schwarz active probe interface interface for R&S®RT-ZL03X logic probe rectangle, Vlow = 0 V, Vhigh = 3.3 V amplitude 3.3 V (Vpp) ± 5 % (meas.) 1 kHz ± 1 % (meas.)
Digital channel inputs Probe compensation output Demo P1 Demo P2 USB interface Rear	D15 to D8, D7 to D0 signal shape frequency analog signal output for demo apps	Rohde & Schwarz active probe interface interface for R&S®RT-ZLO3X logic probe rectangle, Vlow = 0 V, Vhigh = 3.3 V amplitude 3.3 V (Vpp) ± 5 % (meas.) 1 kHz ± 1 % (meas.) VB ≤ ±5.3 V (meas.) V 2 × USB 3.1 Gen 1 ports, type A plug
Digital channel inputs Probe compensation output Demo P1 Demo P2 USB interface Rear Trigger input	D15 to D8, D7 to D0 signal shape frequency analog signal output for demo apps	Rohde & Schwarz active probe interface interface for R&S®RT-ZLO3X logic probe rectangle, Vlow = 0 V, Vhigh = 3.3 V amplitude 3.3 V (Vpp) ± 5 % (meas.) 1 kHz ± 1 % (meas.) Vp ≤ ±5.3 V (meas.) V 2 × USB 3.1 Gen 1 ports, type A plug BNC; for details, see Trigger system
Digital channel inputs Probe compensation output Demo P1 Demo P2 USB interface Rear Trigger input Trigger out	D15 to D8, D7 to D0 signal shape frequency analog signal output for demo apps	Rohde & Schwarz active probe interface interface for R&S®RT-ZLO3X logic probe rectangle, Vlow = 0 V, Vhigh = 3.3 V amplitude 3.3 V (Vpp) ± 5 % (meas.) 1 kHz ± 1 % (meas.) VB ≤ ±5.3 V (meas.) V 2 × USB 3.1 Gen 1 ports, type A plug
Digital channel inputs Probe compensation output Demo P1 Demo P2 USB interface Rear Trigger input Trigger out Waveform generator output	D15 to D8, D7 to D0 signal shape frequency analog signal output for demo apps	Rohde & Schwarz active probe interface interface for R&S®RT-ZLO3X logic probe rectangle, Vlow = 0 V, Vhigh = 3.3 V amplitude 3.3 V (Vpp) ± 5 % (meas.) 1 kHz ± 1 % (meas.) VB ≤ ±5.3 V (meas.) V 2 × USB 3.1 Gen 1 ports, type A plug BNC; for details, see Trigger system BNC; for details, see R&S®MXO3-B6 option 1 × USB 3.1 Gen 1 port, type B plug
Digital channel inputs Probe compensation output Demo P1 Demo P2 USB interface Rear Trigger input Trigger out Waveform generator output (requires R&S*MXO3-B6 option)	D15 to D8, D7 to D0 signal shape frequency analog signal output for demo apps	Rohde & Schwarz active probe interface interface for R&S®RT-ZL03X logic probe rectangle, Vlow = 0 V, Vhigh = 3.3 V amplitude 3.3 V (Vpp) ± 5 % (meas.) 1 kHz ± 1 % (meas.) VB ≤ ±5.3 V (meas.) V 2 × USB 3.1 Gen 1 ports, type A plug BNC; for details, see Trigger system BNC; for details, see Trigger system BNC; for details, see R&S®MXO3-B6 option 1 × USB 3.1 Gen 1 port, type B plug RJ-45 connector, supports 10/100/1000BASE-T,
Digital channel inputs Probe compensation output Demo P1 Demo P2 USB interface Rear Trigger input Trigger out Waveform generator output (requires R&S®MXO3-B6 option) USB interface	D15 to D8, D7 to D0 signal shape frequency analog signal output for demo apps	Rohde & Schwarz active probe interface interface for R&S®RT-ZL03X logic probe rectangle, Vlow = 0 V, Vhigh = 3.3 V amplitude 3.3 V (Vpp) ± 5 % (meas.) 1 kHz ± 1 % (meas.) VB ≤ ±5.3 V (meas.) V 2 × USB 3.1 Gen 1 ports, type A plug BNC; for details, see Trigger system BNC; for details, see Trigger system BNC; for details, see R&S®MXO3-B6 option 1 × USB 3.1 Gen 1 port, type B plug RJ-45 connector, supports 10/100/1000BASE-T, LXI compliant HDMI, 1920 × 1080 pixel at 60 Hz,
Digital channel inputs Probe compensation output Demo P1 Demo P2 USB interface Rear Trigger input Trigger out Waveform generator output (requires R&S®MXO3-B6 option) USB interface LAN interface External monitor interface	D15 to D8, D7 to D0 signal shape frequency analog signal output for demo apps	Rohde & Schwarz active probe interface interface for R&S®RT-ZLO3X logic probe rectangle, Vlow = 0 V, Vhigh = 3.3 V amplitude 3.3 V (Vpp) ± 5 % (meas.) 1 kHz ± 1 % (meas.) VB ≤ ±5.3 V (meas.) V 2 × USB 3.1 Gen 1 ports, type A plug BNC; for details, see Trigger system BNC; for details, see Trigger system BNC; for details, see R&S®MXO3-B6 option 1 × USB 3.1 Gen 1 port, type B plug RJ-45 connector, supports 10/100/1000BASE-T, LXI compliant HDMI, 1920 × 1080 pixel at 60 Hz, output of oscilloscope display
Digital channel inputs Probe compensation output Demo P1 Demo P2 USB interface Rear Trigger input Trigger out Waveform generator output (requires R&S*MXO3-B6 option) USB interface LAN interface	D15 to D8, D7 to D0 signal shape frequency analog signal output for demo apps	Rohde & Schwarz active probe interface interface for R&S®RT-ZL03X logic probe rectangle, Vlow = 0 V, Vhigh = 3.3 V amplitude 3.3 V (Vpp) ± 5 % (meas.) 1 kHz ± 1 % (meas.) VB ≤ ±5.3 V (meas.) V 2 × USB 3.1 Gen 1 ports, type A plug BNC; for details, see Trigger system BNC; for details, see Trigger system BNC; for details, see R&S®MXO3-B6 option 1 × USB 3.1 Gen 1 port, type B plug RJ-45 connector, supports 10/100/1000BASE-T, LXI compliant HDMI, 1920 × 1080 pixel at 60 Hz,

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Ground jack



connected to ground

General data		
Display	tuno	11.6" LC TFT color display with capacitive
	type	touchscreen
	resolution	1920 × 1080 pixel (Full HD)
Temperature		
Temperature range	operating temperature range	0 °C to +45 °C
	storage temperature range	-40 °C to +70 °C
		in line with MIL-PRF-28800F section 4.5.5.1.1.1
		class 3 tailored to +45 °C for operation +25 °C/+45 °C at 95 % relative humidity cyclic,
Climatic resistance	damp heat	in line with IEC 60068-2-30
Altitude		in tine with 120 00000 2 30
Operating		up to 3000 m above sea level
Nonoperating		up to 4600 m above sea level
Mechanical resistance		
		5 Hz to 150 Hz, max. 1.8 g at 55 Hz;
Vibration	sinusoidal	0.5 g from 55 Hz to 150 Hz,
		in line with EN 60068-2-6
		10 Hz to 55 Hz, in line with MIL-PRF-28800F, section 4.5.5.3.2
		class 3
	random	8 Hz to 500 Hz, acceleration 1.2 g (RMS),
	random	in line with EN 60068-2-64
		5 Hz to 500 Hz, acceleration 2.058 g (RMS),
		in line with MIL-PRF-28800F, section 4.5.5.3.1 class 3
		40 g shock spectrum,
Shock		in line with MIL-STD-810G, method no. 516.6,
		procedure I
		30 g functional shock, halfsine, duration 11 ms,
Electromagnetic compatibility (EMC)		in line with MIL-PRF-28800F, section 4.5.5.4.1
Liectromagnetic compatibility (Linc)		in line with CISPR 11/EN 55011 group 1, class A
		(for a shielded test setup);
		the instrument complies with the emission
RF emissions		requirements stipulated by EN 55011,
		EN 61326-1 and EN 61326-2-1 class A, mak-
		ing the instrument suitable for use in industrial environments
Ton many miles		in line with IEC/EN 61326-1 table 2, immunity
Immunity Certifications		test requirements for industrial environment 6)
Calibration interval		VDE, CCSAUS, KC
Power supply		1 year
. сс. сирр.)		
		100 V to 240 V ±10 % at
AC supply		50 Hz to 60 Hz and 400 Hz ±5 %,
		max. 2.8 A to 1.8 A, in line with MIL-PRF 28800F, section 3.5
Power consumption	maximum	280 W
Safety		in line with IEC 61010-1, EN 61010-1,
Mechanical data		CAN/CSA-C22.2 No. 61010-1, UL 61010-1
ricci ai lical data		
Dimensions	$W \times H \times D$	375 mm × 233 mm × 163 mm
Weight	without options, nominal	(14.76 in × 9.17 in × 6.42 in)
Rackmount height	with R&S®ZZA-MXO3 rackmount kit	4.0 kg (8.82 lb) 5 HU
	==	3110

 $^{^{\}rm 6)}~$ Test criterion is displayed noise level within $\pm 1~{\rm div}$ for input sensitivity of 5 mV/div.





ORDERING INFORMATION

Designation	Туре	Order No.
Choose your base model		
Oscilloscope, 100 MHz, 4 channelsMXO 341335.2050.04 Oscilloscope, 100 MHz, 8 channelsMXO 38	1335.2050.08 Base uni	t (including standard
accessories: 500 MHz passive probe (10:1) per channel, accessories bag, quick start guide, power co	rd)	
Choose your bandwidth upgrade		
,		
Jpgrade of MXO 34 to 200 MHz bandwidth Upgrade of MXO 34 to 350 MHz bandwidth	R&S®MXO3-B242	1335,2221.0
Jpgrade of MXO 34 to 500 MHz bandwidth Upgrade of MXO 34 to 1 GHz bandwidth	R&S®MXO3-B243	2
Upgrade of MXO 38 to 200 MHz bandwidth Upgrade of MXO 38 to 350 MHz bandwidth	R&S®MXO3-B245	1335.2244.0
Upgrade of MXO 38 to 500 MHz bandwidth Upgrade of MXO 38 to 1 GHz bandwidth	R&S®MXO3-B2410	2
Choose your options	R&S®MXO3-B282	1335.2267.0
Mixed signal option for MXO 3 series with 16 digital channels Arbitrary waveform generator,	R&S®MXO3-B283	2
50 MHz, 1 analog channel Memory upgrade to 500 Mpoints Power analysis Frequency	R&S®MXO3-B285	1335.2280.0
response analysis Low speed serial buses	R&S®MXO3-B2810	2
(I2C/QuadSPI/SPI/UART/RS-232/RS-422/RS-485/NRZ clocked/NRZ		1335.2815.0
unclocked/Manchester)		2
Automotive protocols (CAN/CAN FD/CAN XL/LIN/SENT)	R&S®MXO3-B1	1335:2923:0
Aerospace protocols (ARINC 429/MIL-STD-1553/SpaceWire)	R&S®MXO3-B6	2
MIPI low speed protocols (SPMI/RFFE/I³C)	R&S®MXO3-B105	1335:2858:8
Automotive Ethernet protocols (10BASE-T1S)	R&S®MXO3-K31	2
R&S®ScopeStudio Software	R&S®MXO3-K36	1335:3844:0
R&S®ScopeStudio Protocol Decode Option	R&S®MXO3-K510	1225 2002 2
Application bundle, consists of the following options:	D&C@MVO2 VE20	1335.2880.0
R&S®MXO3-B6, R&S®MXO3-B105, R&S®MXO3-K31, R&S®MXO3-K36, R&S®MXO3-K510,	R&S®MXO3-K520	2
R&S®MXO3-K520, R&S®MXO3-K530, R&S®MXO3-K550, R&S®MXO3-K560	R&S®MXO3-K530	1335.2896.0
Choose your additional probes	R&S®MXO3-K550	2
	R&S®MXO3-K560	1335.2867.0
	R&S®MXO-PC	
	R&S®MXO-PC-K1	2
		1335.2873.0
	R&S®MXO3-PK1	1 335.2909.02
		1335.2996.0
		2
Single-ended passive probes		1335.5214.0
700 MHz, 10 MΩ, 10:1, 400 V, 9.5 pF, 2.5 mm	R&S®RT-ZP11	3 803.0005.0
500 MHz, 10 MΩ, 10:1, 400 V, 9.5 pF, 2.5 mm	R&S®RT-ZP10	2 335.5943.0
500 MHz, 10 M Ω , 10:1, 300 V, 10 pF, 5 mm	R&S®RT-ZP05M	2 409.7550.0
700 MHz, 14.9 MΩ, 25:1, 30 V, 4 pF, MMCX	R&S®RT-ZPMMCX	Q 801.9005.0
	R&S®RT-ZP1X	1335.3505.0
38 MHz, 1 MΩ, 1:1, 55 V, 39 pF, 2.5 mm	R&S®RT-ZP1X	_
38 MHz, 1 MΩ, 1:1, 55 V, 39 pF, 2.5 mm Active broadband probes: single-ended 1.0 GHz, active, 1 MΩ, Rohde & Schwarz probe interface		1804.8874.0
38 MHz, 1 MΩ, 1:1, 55 V, 39 pF, 2.5 mm Active broadband probes: single-ended 1.0 GHz, active, 1 MΩ, Rohde & Schwarz probe interface	R&S®RT-ZS10E	1804.8874.0 1803.1599.0 1418:7007:02
38 MHz, 1 MΩ, 1:1, 55 V, 39 pF, 2.5 mm Active broadband probes: single-ended 1.0 GHz, active, 1 MΩ, Rohde & Schwarz probe interface 1.0 GHz, active, 1 MΩ, R&S®ProbeMeter, micro button, Rohde & Schwarz probe interface	R&S®RT-ZS10E R&S®RT-ZS10	1804.8874.0 1803.1599.0 1418.7007.02
38 MHz, 1 MΩ, 1:1, 55 V, 39 pF, 2.5 mm Active broadband probes: single-ended	R&S®RT-ZS10E	1804.8874.0
38 MHz, 1 MΩ, 1:1, 55 V, 39 pF, 2.5 mm Active broadband probes: single-ended 1.0 GHz, active, 1 MΩ, Rohde & Schwarz probe interface 1.0 GHz, active, 1 MΩ, R&S®ProbeMeter, micro button, Rohde & Schwarz probe interface 1.5 GHz, active, 1 MΩ, R&S®ProbeMeter, micro button, Rohde & Schwarz probe interface Active broadband probes: differential	R&S®RT-ZS10E R&S®RT-ZS10	1804.8874.0 1803.1599.0 1418:7007:02
38 MHz, 1 MΩ, 1:1, 55 V, 39 pF, 2.5 mm Active broadband probes: single-ended 1.0 GHz, active, 1 MΩ, Rohde & Schwarz probe interface 1.0 GHz, active, 1 MΩ, R&S®ProbeMeter, micro button, Rohde & Schwarz probe interface 1.5 GHz, active, 1 MΩ, R&S®ProbeMeter, micro button, Rohde & Schwarz probe interface Active broadband probes: differential 1.0 GHz, active, differential, 1 MΩ, R&S®ProbeMeter, micro button, incl. 10:1 external attenuator,	R&S®RT-ZS10E R&S®RT-ZS10	1804.8874.0 1803.1599.0 1418.7007.02
38 MHz, 1 MΩ, 1:1, 55 V, 39 pF, 2.5 mm Active broadband probes: single-ended 1.0 GHz, active, 1 MΩ, Rohde & Schwarz probe interface 1.0 GHz, active, 1 MΩ, R&S®ProbeMeter, micro button, Rohde & Schwarz probe interface 1.5 GHz, active, 1 MΩ, R&S®ProbeMeter, micro button, Rohde & Schwarz probe interface Active broadband probes: differential 1.0 GHz, active, differential, 1 MΩ, R&S®ProbeMeter, micro button, incl. 10:1 external attenuator, 1 MΩ, 60 V DC, 42.4 V AC (peak), Rohde & Schwarz probe interface	R&S®RT-ZS10E R&S®RT-ZS10 R&S®RT-ZS20 R&S®RT-	2804.8874.0 2803.1507.02 2418.7507.02 1410.4988.02 1410.3502.02 1410.4715.0
38 MHz, 1 MΩ, 1:1, 55 V, 39 pF, 2.5 mm Active broadband probes: single-ended 1.0 GHz, active, 1 MΩ, Rohde & Schwarz probe interface 1.0 GHz, active, 1 MΩ, R&S®ProbeMeter, micro button, Rohde & Schwarz probe interface 1.5 GHz, active, 1 MΩ, R&S®ProbeMeter, micro button, Rohde & Schwarz probe interface Active broadband probes: differential 1.0 GHz, active, differential, 1 MΩ, R&S®ProbeMeter, micro button, incl. 10:1 external attenuator, 1 MΩ, 60 V DC, 42.4 V AC (peak), Rohde & Schwarz probe interface 1.5 GHz, active, differential, 1 MΩ, R&S®ProbeMeter, micro button, Rohde & Schwarz probe interface	R&S®RT-ZS10E R&S®RT-ZS10 R&S®RT-ZS20	1804.8874.0 1803.1509.02 1418.7509.02 1410.4080.02 1410.3502.02
Active broadband probes: single-ended L.O GHz, active, 1 MΩ, Rohde & Schwarz probe interface L.O GHz, active, 1 MΩ, Rohde & Schwarz probe interface L.O GHz, active, 1 MΩ, R&S®ProbeMeter, micro button, Rohde & Schwarz probe interface L.5 GHz, active, 1 MΩ, R&S®ProbeMeter, micro button, Rohde & Schwarz probe interface Active broadband probes: differential L.O GHz, active, differential, 1 MΩ, R&S®ProbeMeter, micro button, incl. 10:1 external attenuator, L MΩ, 60 V DC, 42.4 V AC (peak), Rohde & Schwarz probe interface L.5 GHz, active, differential, 1 MΩ, R&S®ProbeMeter, micro button, Rohde & Schwarz probe interface Power rail probe	R&S*RT-ZS10E R&S*RT-ZS10 R&S*RT-ZS20 R&S*RT- ZD10 R&S*RT-	1804.8874.0 1803.1599.0 1418.7509.02 1410.4980.02 1410.3502.02 1410.4715.0 2 1410.4409.0
38 MHz, 1 MΩ, 1:1, 55 V, 39 pF, 2.5 mm Active broadband probes: single-ended L.0 GHz, active, 1 MΩ, Rohde & Schwarz probe interface L.0 GHz, active, 1 MΩ, R&S®ProbeMeter, micro button, Rohde & Schwarz probe interface L.5 GHz, active, 1 MΩ, R&S®ProbeMeter, micro button, Rohde & Schwarz probe interface Active broadband probes: differential L.0 GHz, active, differential, 1 MΩ, R&S®ProbeMeter, micro button, incl. 10:1 external attenuator, L MΩ, 60 V DC, 42.4 V AC (peak), Rohde & Schwarz probe interface L.5 GHz, active, differential, 1 MΩ, R&S®ProbeMeter, micro button, Rohde & Schwarz probe interface Power rail probe 2.0 GHz, 1:1, 50 kΩ, ±0.85 V, ±60 V offset, Rohde & Schwarz probe interface	R&S*RT-ZS10E R&S*RT-ZS10 R&S*RT-ZS20 R&S*RT- ZD10 R&S*RT- R&S*RT- R&S*RT-ZPR20	1804.8874.0 1803.15097.02 1418.7007.02 1419.4988.02 1410.3502.02 1410.4715.0 2 1410.4409.0 1800.5006.02
38 MHz, 1 MΩ, 1:1, 55 V, 39 pF, 2.5 mm Active broadband probes: single-ended L.O GHz, active, 1 MΩ, Rohde & Schwarz probe interface L.O GHz, active, 1 MΩ, R&S®ProbeMeter, micro button, Rohde & Schwarz probe interface L.5 GHz, active, 1 MΩ, R&S®ProbeMeter, micro button, Rohde & Schwarz probe interface Active broadband probes: differential L.O GHz, active, differential, 1 MΩ, R&S®ProbeMeter, micro button, incl. 10:1 external attenuator, L MΩ, 60 V DC, 42.4 V AC (peak), Rohde & Schwarz probe interface L.5 GHz, active, differential, 1 MΩ, R&S®ProbeMeter, micro button, Rohde & Schwarz probe interface Power rail probe 2.0 GHz, 1:1, 50 kΩ, ±0.85 V, ±60 V offset, Rohde & Schwarz probe interface High voltage probes: passive	R&S*RT-ZS10E R&S*RT-ZS10 R&S*RT-ZS20 R&S*RT- ZD10 R&S*RT-	1804.8874.0 1803.1599.0 1418.7007.02 1410.4980.02 1410.3502.02 1410.4715.0 2 1410.4409.0
38 MHz, 1 MΩ, 1:1, 55 V, 39 pF, 2.5 mm Active broadband probes: single-ended 1.0 GHz, active, 1 MΩ, Rohde & Schwarz probe interface 1.0 GHz, active, 1 MΩ, R&S®ProbeMeter, micro button, Rohde & Schwarz probe interface 1.5 GHz, active, 1 MΩ, R&S®ProbeMeter, micro button, Rohde & Schwarz probe interface Active broadband probes: differential 1.0 GHz, active, differential, 1 MΩ, R&S®ProbeMeter, micro button, incl. 10:1 external attenuator, 1 MΩ, 60 V DC, 42.4 V AC (peak), Rohde & Schwarz probe interface 1.5 GHz, active, differential, 1 MΩ, R&S®ProbeMeter, micro button, Rohde & Schwarz probe interface Power rail probe 2.0 GHz, 1:1, 50 kΩ, ±0.85 V, ±60 V offset, Rohde & Schwarz probe interface High voltage probes: passive 250 MHz, 100:1, 100 MΩ, 850 V, 6.5 pF	R&S*RT-ZS10E R&S*RT-ZS10 R&S*RT-ZS20 R&S*RT- ZD10 R&S*RT- R&S*RT- R&S*RT-ZPR20	1804.8874.0 1803.15097.02 1418.7007.02 1419.4988.02 1410.3502.02 1410.4715.0 2 1410.4409.0 1800.5006.02
38 MHz, 1 MΩ, 1:1, 55 V, 39 pF, 2.5 mm Active broadband probes: single-ended 1.0 GHz, active, 1 MΩ, Rohde & Schwarz probe interface 1.0 GHz, active, 1 MΩ, R&S®ProbeMeter, micro button, Rohde & Schwarz probe interface 1.5 GHz, active, 1 MΩ, R&S®ProbeMeter, micro button, Rohde & Schwarz probe interface Active broadband probes: differential 1.0 GHz, active, differential, 1 MΩ, R&S®ProbeMeter, micro button, incl. 10:1 external attenuator, 1 MΩ, 60 V DC, 42.4 V AC (peak), Rohde & Schwarz probe interface 1.5 GHz, active, differential, 1 MΩ, R&S®ProbeMeter, micro button, Rohde & Schwarz probe interface Power rail probe 2.0 GHz, 1:1, 50 kΩ, ±0.85 V, ±60 V offset, Rohde & Schwarz probe interface High voltage probes: passive 250 MHz, 100:1, 100 MΩ, 850 V, 6.5 pF 400 MHz, 100:1, 50 MΩ, 1000 V, 7.5 pF	R&S®RT-ZS10E R&S®RT-ZS10 R&S®RT-ZS20 R&S®RT- ZD10 R&S®RT- R&S®RT- R&S®RT- R&S®RT- R&S®RT- R&S®RT- R&S®RT-ZPR20 ZD20	1804.8874.0 1803.1599.0 1418.7007.02 1410.4080.02 1410.3502.02 1410.4715.0 2 1410.4409.0 1800.5006.02 2
38 MHz, 1 MΩ, 1:1, 55 V, 39 pF, 2.5 mm Active broadband probes: single-ended 1.0 GHz, active, 1 MΩ, Rohde & Schwarz probe interface 1.0 GHz, active, 1 MΩ, R&S*ProbeMeter, micro button, Rohde & Schwarz probe interface 1.5 GHz, active, 1 MΩ, R&S*ProbeMeter, micro button, Rohde & Schwarz probe interface Active broadband probes: differential 1.0 GHz, active, differential, 1 MΩ, R&S*ProbeMeter, micro button, incl. 10:1 external attenuator, 1 MΩ, 60 V DC, 42.4 V AC (peak), Rohde & Schwarz probe interface 1.5 GHz, active, differential, 1 MΩ, R&S*ProbeMeter, micro button, Rohde & Schwarz probe interface Power rail probe 2.0 GHz, 1:1, 50 kΩ, \pm 0.85 V, \pm 60 V offset, Rohde & Schwarz probe interface High voltage probes: passive 250 MHz, 100:1, 100 MΩ, 850 V, 6.5 pF 400 MHz, 100:1, 50 MΩ, 1000 V, 7.5 pF	R&S®RT-ZS10E R&S®RT-ZS10 R&S®RT-ZS20 R&S®RT- ZD10 R&S®RT- R&S®RT- R&S®RT- R&S®RT-ZPR20 ZD20 R&S®RT-ZH03	1804.8874.0 1803.1599.0 1418.7007.02 1410.4088.02 1410.3502.02 1410.4715.0 2 1410.4409.0 1800.5006.02 2 1333.0873.02
38 MHz, 1 MΩ, 1:1, 55 V, 39 pF, 2.5 mm Active broadband probes: single-ended 1.0 GHz, active, 1 MΩ, Rohde & Schwarz probe interface 1.0 GHz, active, 1 MΩ, R&S®ProbeMeter, micro button, Rohde & Schwarz probe interface 1.5 GHz, active, 1 MΩ, R&S®ProbeMeter, micro button, Rohde & Schwarz probe interface Active broadband probes: differential 1.0 GHz, active, differential, 1 MΩ, R&S®ProbeMeter, micro button, incl. 10:1 external attenuator, 1 MΩ, 60 V DC, 42.4 V AC (peak), Rohde & Schwarz probe interface 1.5 GHz, active, differential, 1 MΩ, R&S®ProbeMeter, micro button, Rohde & Schwarz probe interface Power rail probe 2.0 GHz, 1:1, 50 kΩ, ±0.85 V, ±60 V offset, Rohde & Schwarz probe interface High voltage probes: passive 250 MHz, 100:1, 100 MΩ, 850 V, 6.5 pF 400 MHz, 100:1, 50 MΩ, 1000 V, 7.5 pF High voltage probes: differential	R&S®RT-ZS10E R&S®RT-ZS10 R&S®RT-ZS20 R&S®RT- ZD10 R&S®RT- R&S®RT- R&S®RT- R&S®RT-ZPR20 ZD20 R&S®RT-ZH03 R&S®RT-ZH10	2 1410.4409.0 1410.4409.0 2 1410.4409.0 2 1410.4409.0 1800.5006.02 2 1333.0873.02
38 MHz, 1 MΩ, 1:1, 55 V, 39 pF, 2.5 mm Active broadband probes: single-ended L.0 GHz, active, 1 MΩ, Rohde & Schwarz probe interface L.0 GHz, active, 1 MΩ, R&S®ProbeMeter, micro button, Rohde & Schwarz probe interface L.5 GHz, active, 1 MΩ, R&S®ProbeMeter, micro button, Rohde & Schwarz probe interface Active broadband probes: differential L.0 GHz, active, differential, 1 MΩ, R&S®ProbeMeter, micro button, incl. 10:1 external attenuator, L MΩ, 60 V DC, 42.4 V AC (peak), Rohde & Schwarz probe interface L.5 GHz, active, differential, 1 MΩ, R&S®ProbeMeter, micro button, Rohde & Schwarz probe interface Power rail probe 2.0 GHz, 1:1, 50 kΩ, ±0.85 V, ±60 V offset, Rohde & Schwarz probe interface High voltage probes: passive 2.50 MHz, 100:1, 100 MΩ, 850 V, 6.5 pF 3.60 MHz, 100:1, 50 MΩ, 1000 V, 7.5 pF 3.60 MHz, 1000:1, 50 MΩ, 1000 V, 7.5 pF 3.60 MHz, 1000:1, 50 MΩ, 1000 V, 7.5 pF 3.60 MHz, 1000:1, 50 MΩ, 1000 V, 7.5 pF 3.60 MHz, 250:1/25:1, 5 MΩ, 750 V (peak), 300 V CAT III, Rohde & Schwarz probe interface	R&S®RT-ZS10E R&S®RT-ZS10 R&S®RT-ZS20 R&S®RT- ZD10 R&S®RT- R&S®RT- R&S®RT- R&S®RT-ZPR20 ZD20 R&S®RT-ZH03 R&S®RT-ZH10	2 1410.4409.0 1410.4409.0 2 1410.4409.0 2 1410.4409.0 1800.5006.02 2 1333.0873.02
Active broadband probes: single-ended 1.0 GHz, active, 1 MΩ, Rohde & Schwarz probe interface 1.0 GHz, active, 1 MΩ, R&S®ProbeMeter, micro button, Rohde & Schwarz probe interface 1.5 GHz, active, 1 MΩ, R&S®ProbeMeter, micro button, Rohde & Schwarz probe interface 1.5 GHz, active, 1 MΩ, R&S®ProbeMeter, micro button, Rohde & Schwarz probe interface 1.0 GHz, active, differential, 1 MΩ, R&S®ProbeMeter, micro button, incl. 10:1 external attenuator, 1 MΩ, 60 V DC, 42.4 V AC (peak), Rohde & Schwarz probe interface 1.5 GHz, active, differential, 1 MΩ, R&S®ProbeMeter, micro button, Rohde & Schwarz probe interface 1.5 GHz, active, differential, 1 MΩ, R&S®ProbeMeter, micro button, Rohde & Schwarz probe interface 1.6 GHz, 1:1, 50 kΩ, ±0.85 V, ±60 V offset, Rohde & Schwarz probe interface 1.7 GHz, 1:1, 50 kΩ, ±0.85 V, ±60 V offset, Rohde & Schwarz probe interface 1.8 GHz, 1:1, 50 kΩ, ±0.85 V, ±60 V offset, Rohde & Schwarz probe interface 1.9 GHz, 1:1, 50 kΩ, ±0.85 V, ±60 V offset, Rohde & Schwarz probe interface 1.9 GHz, 1:1, 50 kΩ, ±0.85 V, ±60 V offset, Rohde & Schwarz probe interface 1.9 GHz, 1:1, 50 kΩ, ±0.85 V, ±60 V offset, Rohde & Schwarz probe interface 1.9 GHz, 1:1, 50 kΩ, ±0.85 V, ±60 V offset, Rohde & Schwarz probe interface 1.9 GHz, 1:1, 50 kΩ, ±0.85 V, ±60 V offset, Rohde & Schwarz probe interface 1.9 GHz, 1:1, 50 kΩ, ±0.85 V, ±60 V offset, Rohde & Schwarz probe interface 1.9 GHz, 1:1, 50 kΩ, ±0.85 V, ±60 V offset, Rohde & Schwarz probe interface 1.9 GHz, 1:1, 50 kΩ, ±0.85 V, ±60 V offset, Rohde & Schwarz probe interface 1.9 GHz, 1:1, 50 kΩ, ±0.85 V, ±60 V offset, Rohde & Schwarz probe interface 1.9 GHz, ±0.9 GHz, ±0.	R&S®RT-ZS10E R&S®RT-ZS10 R&S®RT-ZS20 R&S®RT- ZD10 R&S®RT- R&S®RT- R&S®RT-ZPR20 ZD20 R&S®RT-ZH03 R&S®RT-ZH10 R&S®RT-ZH11	2 1410.4409.0 1409.7720.02 1410.4980.02 1410.4715.0 2 1410.4409.0 1800.5006.02 2 14333.0873.02 1409.7720.02 1409.7737.02
38 MHz, 1 MΩ, 1:1, 55 V, 39 pF, 2.5 mm Active broadband probes: single-ended 1.0 GHz, active, 1 MΩ, Rohde & Schwarz probe interface 1.0 GHz, active, 1 MΩ, R&S®ProbeMeter, micro button, Rohde & Schwarz probe interface 1.5 GHz, active, 1 MΩ, R&S®ProbeMeter, micro button, Rohde & Schwarz probe interface	R&S*RT-ZS10E R&S*RT-ZS10 R&S*RT-ZS20 R&S*RT- ZD10 R&S*RT- R&S*RT- R&S*RT-ZPR20 ZD20 R&S*RT-ZH03 R&S*RT-ZH10 R&S*RT-ZH11 R&S*RT-ZH11	2 1410.4409.0 1410.4715.0 2 1410.4409.0 1800.5006.02 2 1410.4715.0 2 1410.4409.0 1800.5006.02 2 1410.4715.0

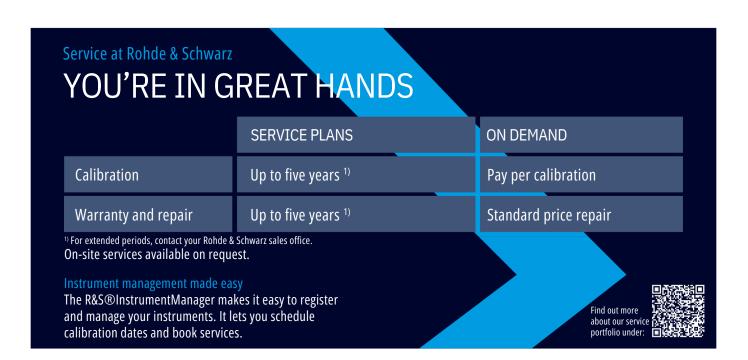




+33(0)2 99 14 69 65

Designation	Туре	Order No.
Current probes		
20 kHz, AC/DC, 0.01 V/A and 0.001 V/A, ±200 A and ±2000 A, BNC interface	R&S®RT-ZC02	1333.0850.0
100 kHz, AC/DC, 0.1 V/A, 30 A, BNC interface	R&S®RT-ZC03	2
2 MHz, AC/DC, 0.01 V/A, 500 A (RMS), Rohde & Schwarz probe interface	R&S®RT-	1333.0844.0
10 MHz, AC/DC, 0.01 V/A, 150 A (RMS), BNC interface	ZC05B	2
10 MHz, AC/DC, 0.01 V/A, 150 A (RMS), Rohde & Schwarz probe interface	R&S®RT-ZC10	1409.8204.0
50 MHz, AC/DC, 0.1 V/A, 30 A (RMS), Rohde & Schwarz probe interface	R&S®RT-	2
100 MHz, AC/DC, 0.1 V/A, 30 A (RMS), BNC interface	ZC10B	1409.7750.0
100 MHz, AC/DC, 0.1 V/A, 30 A (RMS), Rohde & Schwarz probe interface	R&S®RT-	2
120 MHz, AC/DC, 1 V/A, 5 A (RMS), BNC interface	ZC15B	1409.8210.0
EMC near-field probe	R&S®RT-ZC20	2
Probe set for E and H near-field measurements, 30 MHz to 3 GHz Logic probe 1)	R&S®RT- B&S®BZ-15 Z&20B	1409.8227.0 1147.2736.02
300 MHz logic probe, 8 channels	R&S®RT-ZC30	1409.7766.0
Probe accessories	R&S®RT-ZL03X	1 335.3005.02
		1409.8233.0
Accessory set for R&S®RT-ZP10/-ZP11 passive probe (2.5 mm probe tip)	R&S®RT-ZA1	2 409.7566.02
Probe power supply for R&S®RT-ZC10/-ZC20/-ZC30	R&S®RT-ZA13	1409.7789.02
External attenuator 10:1, 2.0 GHz, 1.3 pF, 60 V DC, 42.4 V AC (peak), for R&S®RT-ZD20/-ZD30 probes	R&S®RT-ZA15	2 410.4744.02
Probe pouch for the logic probes	R&S®RT-ZA19	1335.7875.02
Power deskew and calibration test fixture	R&S®RT-ZF20	1800.0004.02
3D positioner with central tensioning knob for easy clamping and positioning of probes (span width: 200 mm, clamping range: 15 mm) Choose your accessories	R&S®RT-ZA1P	1326.3641.02
Front cover	R&S®MXO3-Z1	1335.1902.02
Soft case	R&S®MXO3-Z3	1335.1919.02
Transit case	R&S®MXO3-Z4	1335.1925.02
Rackmount kit, for MXO 3 oscilloscopes with 5 HU	R&S®ZZA-MXO3 1335.2715.02 Choose	
VESA mount (compatible with standard 100 mm × 100 mm pattern)	industry standard moun	ts

¹⁾ The R&S®MXO3-B1 mixed signal option contains two R&S®RT-ZLO3X logic probes.







OUR OSCILLOSCOPE PORTFOLIO









Rohde & Schwarz MXO 3 Series Oscilloscope 45imac

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OSCILLOSCOPE PORTFOLIO









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	R&S®RTH1000	R&S®RTC1000	R&S®RTB 2	MXO 3
Vertical system				
Bandwidth 1)	60/100/200/350/500 MHz	50/70/100/200/300 MHz	70/100/200/300 MHz	100/200/350/500 MHz/1 GHz
Number of channels	2 plus DMM/4	2	2/4	4/8
Vertical resolution;	10 bit; 16 bit	8 bit; 16 bit	10 bit; 16 bit	12 bit; 18 bit
system architecture	,			
V/div, 1 MΩ	2 mV to 100 V	1 mV to 10 V	1 mV to 5 V	1 mV to 10 V
V/div, 50 Ω Digital channels	-			1 mV to 1 V
Horizontal system	8	8	16	16
Sampling rate per channel (in Gsample/s)	1.25 (4-channel model); 2.5 (2-channel model); 5 (all channels interleaved)	1; 2 (2 channels interleaved)	1.25; 2.5 (2 channels interleaved)	2.5; 5 (2 channels interleaved)
Maximum memory (per channel; 1 channel active)	125 kpoints (4-channel model); 250 kpoints (2-channel model); 500 kpoints	1 Mpoint; 2 Mpoints	10 Mpoints; 20 Mpoints	standard: 125 Mpoints; max. upgrade: 500 Mpoints 2)
Segmented memory	standard, 50 Mpoints	-	standard, 160 Mpoints	standard: 10 000 segments; option: 1 000 000 segments
Acquisition rate (in waveforms/s)	50 000	10 000	50 000 (300 000 in fast seg- mented memory mode)	> 4 500 000 on 4 channels
Trigger				
Types	digital	analog	analog	advanced (includes zone trigger), digital trigger (15 trigger types)
Sensitivity	-	-	at 1 mV/div: > 2 div	0.0001 div, across full bandwidth, user controllable
Analysis				
Mask test	tolerance mask	tolerance mask	tolerance mask	user configurable, hardware based
Mathematics	elementary	elementary	basic (math on math)	advanced (formula editor)
Serial protocols triggering and decoding 1)	I2C, SPI, UART/RS-232/RS-422/ RS-485, CAN, LIN, CAN FD, SENT	I2C, SPI, UART/RS-232/RS-422/ RS-485, CAN, LIN	I2C, SPI, UART/RS-232/RS-422/ RS-485, CAN, LIN	I2C, SPI, UART/RS-232/RS-422/RS-485, CAN, CAN FD, CAN XL, LIN, ARINC 429, MIL-STD-1553, SPMI, 10BASE-T1S, QUAD-SPI, SENT, RFFE I3C, NRZ, SpaceWire, Manchester
Applications ^{1), 2)}	high-resolution frequency counter, advanced spectrum analysis, harmonics analysis, user scripting	digital voltmeter (DVM), com- ponent tester, fast Fourier trans- form (FFT)	digital voltmeter (DVM), fast Fourier transform (FFT), frequency response analysis	power, digital voltmeter (DVM), frequency response analysis
Compliance testing 1), 2)	-	-	-	-
Display and operation				
Size and resolution	7" touchscreen, 800 × 480 pixel	6.5", 640 × 480 pixel	10.1" touchscreen, 1280 × 800 pixel	11.6" touchscreen, 1920 × 1080 pixel (Full HD)
General data				
Dimensions in mm (W × H × D)	201 × 293 × 74	285 × 175 × 140	390 × 220 × 152	375 × 233 × 163
Weight in kg	2.4	1.7	2.5	4
Battery	lithium-ion, > 4 h	_	_	-

¹⁾ Upgradeable.





²⁾ Requires an option.









M XO 4	M XO 5 / M XO 5 C	R&S®RTO6	R&S®RTP
200/350/500 MHz/1/1.5 GHz	100/200/350/500 MHz/1/2 GHz	600 MHz/1/2/3/4/6 GHz	4/6/8/13/16 GHz
4	4/8	4	4
12 bit; 18 bit	12 bit; 18 bit	8 bit; 16 bit	8 bit; 16 bit
500 μV to 10 V	500 μV to 10 V	1 mV to 10 V (HD mode: 500 μV to 10 V)	
500 μV to 1 V	500 μV to 1 V	1 mV to 1 V (HD mode: 500 μV to 1 V)	2 mV to 1 V (HD mode: 1 mV to 1 V)
16	16	16	16
2.5; 5 (2 channels interleaved)	5 on 4 channels; 2.5 on 8 channels (2 channels interleaved)	10; 20 (2 channels interleaved in 4 GHz and 6 GHz model)	20; 40 (2 channels interleaved)
standard: 400 Mpoints; max. upgrade: 800 Mpoints 2)	standard: 500 Mpoints max. upgrade: 1 Gpoint ²⁾	standard: 200 Mpoints/800 Mpoints; max. upgrade: 1 Gpoint/2 Gpoints	standard: 100 Mpoints/400 Mpoints; max. upgrade: 3 Gpoints
standard: 10 000 segments; option: 1 000 000 segments	standard: 10 000 segments; option: 1 000 000 segments	standard	standard
> 4 500 000	> 4 500 000 on 4 channels	1 000 000 (2 500 000 in ultra-segmented memory mode)	750 000 (> 3 000 000 in ultra-segmented memory mode)
advanced (includes zone trigger), digital trigger (15 trigger types)	advanced (includes zone trigger), digital trigger (15 trigger types)	advanced (includes zone trigger), digital trigger (15 trigger types), high speed serial pattern trigger including 5 Gbps clock data recovery (CDR) 2)	advanced (includes zone trigger), digital trigger (14 trigger types) with real-time deembedding 2), high speed serial pattern trig- ger including 8/16 Gbps clock data recovery (CDR) 2)
0.0001 div, across full bandwidth, user controllable	0.0001 div, across full bandwidth, user controllable	0.0001 div, across full bandwidth, user controllable	0.0001 div, across full bandwidth, user controllable
user configurable, hardware based	user configurable, hardware based	user configurable, hardware based advanced	user configurable, hardware based advance
advanced (formula editor)	advanced (formula editor)	(formula editor, Python interface) I2C, SPI,	
I2C, SPI, UART/RS-232/RS-422/ RS-485, CAN, CAN FD, CAN XL, LIN, ARINC 429, MIL-STD-1553, SPMI, 10BASE-T1S, QUAD-SPI, SENT, RFFE, I3C, NRZ, Manchester, SpaceWire	I2C, SPI, UART/RS-232/RS-422/ RS-485, CAN, CAN FD, CAN XL, LIN, ARINC 429, MIL-STD-1553, SPMI, 10BASE-T1S, 100/1000BASE-T1, QUAD-SPI, SENT, RFFE, I3C, NRZ, Manchester, SpaceWire	100/1000BASE-T1	429, SpaceWire, USB 2.0/HSIC/PD, USB 3. Gen 1/Gen 2/SSIC, PCIe 1.1/2.0/3.0, 8b10b MIPI RFFE, MIPI D/M-PHY/UniPro, Automotiv
power, digital voltmeter (DVM), frequency response analysis, basic jitter analysis	power, digital voltmeter (DVM), frequency response analysis, basic jitter analysis, eye analysis	power, advanced spectrum analysis and spectrogram, jitter and noise decomposition, clock data recovery (CDR), I/Q data and RF analysis (R&S®VSE), deembedding, embedding, equalization, PAM-N, TDR/TDT analysis, advanced eye diagram see specifications (PD 5216.1640.22)	advanced spectrum analysis and spectrogram, jitter and noise decomposition, real-time deembedding, embedding, equalization, PAM-N, TDR/TDT analysis, I/Q data and RF analysis (R&S®VSE), advanced eye diagram
-			see specifications (PD 3683.5616.22)
13.3" touchscreen,	for MXO 5 only: 15.6" touchscreen,	15.6" touchscreen,	13.3" touchscreen,
1920 × 1080 pixel (Full HD)	1920 × 1080 pixel (Full HD)	1920 × 1080 pixel (Full HD)	1920 × 1080 pixel (Full HD)
414 × 279 × 162	MXO 5: 445 × 314 × 154 MXO 5C: 445 × 105 × 405	450 × 315 × 204	441 × 285 × 316
6	MXO 5: 9 MXO 5C: 8.7	10.7	18
-	-	-	-



